

TEST REPORT

FCC SAR Part 2 Test for SM-A266U
Certification

APPLICANT
SAMSUNG Electronics Co., Ltd.

REPORT NO.
HCT-SR-2501-FC003-R1

DATE OF ISSUE
February 4, 2025

Tested by
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TEST REPORT

PART 2 RF Exposure
Compliance Test
for certification

REPORT NO.

HCT-SR-2501-FC003-R1

DATE OF ISSUE

Feb. 04, 2025

FCC ID

A3LSMA266U

Applicant

SAMSUNG Electronics Co., Ltd
129, Samsung-ro, Yeongtong-gu, Suwon-Si, Gyeonggi-do, 16677, Korea

Product Name

Mobile Phone

Model Name

SM-A266U

Additional Model Name

SM-A266U1, SM-S266V

Date of Test

Jan. 06, 2025 ~ Jan. 10, 2025

Location of Test

☒ Permanent Testing Lab ☐ On Site Testing Lab
(Address: 74, Seoicheon-ro 578beon-gil, Majang-myeon, Icheon-si,
Gyeonggi-do, 17383 KOREA)

FCC Rule Part(s)

CFR § 2.1093

Results

Pass

REVISION HISTORY

The revision history for this test report is shown in table.

Revision No.	Date of Issue	Description
0	Jan. 15, 2025	Initial Release
1	Feb. 04, 2025	Typo Revised Page 30

Notice

Content

The results shown in this test report only apply to the sample(s), as received, provided by the applicant, unless otherwise stated.

The test results have only been applied with the test methods required by the standard(s).

The laboratory is not accredited for the test results marked *.

Information provided by the applicant is marked **.

Test results provided by external providers are marked ***.

When confirmation of authenticity of this test report is required, please contact www.hct.co.kr

The test results in this test report are not associated with the ((KS Q) ISO/IEC 17025) accreditation by KOLAS (Korea Laboratory Accreditation Scheme) / A2LA (American Association for Laboratory Accreditation) that are under the ILAC (International Laboratory Accreditation Cooperation) Mutual Recognition Agreement (MRA).

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1. RF Exposure Limits

1.1 RF Exposure Limits for Frequencies < 6 GHz

HUMAN EXPOSURE	UNCONTROLLED ENVIRONMENT General Population (W/kg) or (mW/g)	CONTROLLED ENVIRONMENT Occupational (W/kg) or (mW/g)
SPATIAL PEAK SAR * (Partial Body)	1.6	8.0
SPATIAL AVERAGE SAR ** (Whole Body)	0.08	0.4
SPATIAL PEAK SAR *** (Hands / Feet / Ankle / Wrist)	4.0	20.0

NOTES:

* The Spatial Peak value of the SAR averaged over any 1 g of tissue (defined as a tissue volume in the shape of a cube) and over the appropriate averaging time.

** The Spatial Average value of the SAR averaged over the whole-body.

*** The Spatial Peak value of the SAR averaged over any 10 g of tissue (defined as a tissue volume in the shape of a cube) and over the appropriate averaging time.

Uncontrolled Environments are defined as locations where there is the exposure of individuals who have no knowledge or control of their exposure. The general population/uncontrolled exposure limits are applicable to situations in which the general public may be exposed or in which persons who are exposed as a consequence of their employment may not be made fully aware of the potential for exposure or cannot exercise control over their exposure. Members of the general public would come under this category when exposure is not employment-related; for example, in the case of a wireless transmitter that exposes persons in its vicinity.

Controlled Environments are defined as locations where there is exposure that may be incurred by persons who are aware of the potential for exposure, (i.e. as a result of employment or occupation). In general, occupational/controlled exposure limits are applicable to situations in which persons are exposed as a consequence of their employment, who have been made fully aware of the potential for exposure and can exercise control over their exposure. This exposure category is also applicable when the exposure is of a transient nature due to incidental passage through a location where the exposure levels may be higher than the general population/uncontrolled limits, but the exposed person is fully aware of the potential for exposure and can exercise control over his or her exposure by leaving the area or by some other appropriate means.

1.2 Time-averaging in RFX Evaluations

Per October 2023 TCB Workshop Notes, the below time-averaging windows can be used for assessing time-averaged exposures for devices that are capable of actively monitoring and adjusting power output over time to comply with exposure limits.

Frequency (GHz):	< 3	3–6	6–10	10–16	16–24	24–42	42–95
Max. Averaging Time (s):	100	60	30	14	8	4	2
From: Oct. 2018 TCBC Workshop, "RF Exposure Order of Magnitude Issues"							

Note:

S.LSI's TAS algorithm applies an overall average time of 60 seconds for communication modes below 6 GHz frequency to control the output in the worst case.

2. Test Location

2.1 Test Laboratory

Company Name	HCT Co., Ltd.
Address	74, Seoicheon-ro 578beon-gil, Majang-myeon, Icheon-si, Gyeonggi-do, 17383 KOREA
Telephone	031-645-6300
Fax.	031-645-6401

2.2 Test Facilities

Our laboratories are accredited and approved by the following approval agencies according to ISO/IEC 17025.

Korea	National Radio Research Agency (Designation No. KR0032)
	KOLAS (Testing No. KT197)

2.3 General Information of the EUT

Model Name	SM-A266U
Additional Model Name	SM-A266U1, SM-S266V
Equipment Type	Mobile Phone
FCC ID	A3LSMA266U
Application Type	Certification
Applicant	SAMSUNG Electronics Co., Ltd.

3. DEVICE UNDER TEST DESCRIPTION

3.1 DUT specification

Device Wireless specification overview		
Band & Mode	Operating Mode	Tx Frequency
GSM850	Voice / Data	824.2 MHz ~ 848.8 MHz
GSM1900	Voice / Data	1 850.2 MHz ~ 1 909.8 MHz
UMTS Band 2	Voice / Data	1 852.4 MHz ~ 1 907.6 MHz
UMTS Band 4	Voice / Data	1 712.4 MHz ~ 1 752.6 MHz
UMTS Band 5	Voice / Data	826.4 MHz ~ 846.6 MHz
LTE FDD Band 2 (PCS)	Voice / Data	1 850.7 MHz ~ 1 909.3 MHz
LTE FDD Band 4 (AWS)	Voice / Data	1 710.7 MHz ~ 1 754.3 MHz
LTE FDD Band 5 (Cell)	Voice / Data	824.7 MHz ~ 848.3 MHz
LTE FDD Band 7	Voice / Data	2 502.5 MHz ~ 2 567.5 MHz
LTE FDD Band 12	Voice / Data	699.7 MHz ~ 715.3 MHz
LTE FDD Band 13	Voice / Data	779.5 MHz ~ 784.5 MHz
LTE FDD Band 14	Voice / Data	790.5 MHz ~ 795.5 MHz
LTE FDD Band 25	Voice / Data	1 850.7 MHz ~ 1 914.3 MHz
LTE FDD Band 26	Voice / Data	814.7 MHz ~ 848.3 MHz
LTE FDD Band 30	Voice / Data	2 307.5 MHz ~ 2 312.5 MHz
LTE TDD Band 38	Voice / Data	2 572.5 MHz ~ 2 617.5 MHz
LTE TDD Band 41	Voice / Data	2 498.5 MHz ~ 2 687.5 MHz
LTE TDD Band 48	Voice / Data	3 552.5 MHz ~ 3 697.5 MHz
LTE FDD Band 66 (AWS)	Voice / Data	1 710.7 MHz ~ 1 779.3 MHz
LTE FDD Band 71	Voice / Data	665.5 MHz ~ 695.5 MHz
NR FDD Band n2 (PCS)	Voice / Data	1 852.5 MHz ~ 1 907.5 MHz
NR FDD Band n5	Voice / Data	826.5 MHz ~ 846.5 MHz
NR FDD Band n25 (PCS)	Voice / Data	1 852.5 MHz ~ 1 912.5 MHz
NR FDD Band n30	Voice / Data	2 307.5 MHz ~ 2 312.5 MHz
NR TDD Band n41	Voice / Data	2 501.01 MHz ~ 2 685 MHz
NR TDD Band n48	Voice / Data	3 555 MHz ~ 3 695.01 MHz
NR FDD Band n66	Voice / Data	1 712.5 MHz ~ 1 777.5 MHz
NR FDD Band n71	Voice / Data	665.5 MHz ~ 695.5 MHz
NR TDD Band n77	Voice / Data	3 705 MHz ~ 3 975 MHz
NR TDD Band n77 DoD	Voice / Data	3 445.01 MHz ~ 3 544.98 MHz
NR TDD Band n78	Voice / Data	3 705 MHz ~ 3 795 MHz
NR TDD Band n78 DoD	Voice / Data	3 455.01 MHz ~ 3 544.98 MHz
U-NII-1	Voice / Data	5 180 MHz ~ 5 240 MHz
U-NII-2A	Voice / Data	5 260 MHz ~ 5 320 MHz
U-NII-2C	Voice / Data	5 500 MHz ~ 5 720 MHz
U-NII-3	Voice / Data	5 745 MHz ~ 5 825 MHz
U-NII-4	Voice / Data	5 845 MHz ~ 5 885 MHz
2.4 GHz WLAN	Voice / Data	2 412 MHz ~ 2 462 MHz
Bluetooth / LE 5.3	Data	2 402 MHz ~ 2 480 MHz
NFC	Data	13.56 MHz

Device Description		
Battery	EB-BA166ASY (ATL)	
Device Serial Numbers	Mode	Serial Number
	Main	XKP0544M
	WLAN 2.4G, 5G, BT	XL01251M
	The manufacturer has confirmed that the devices tested have the same physical, mechanical and thermal characteristics are within operational tolerances expected for production units.	

Measurement Results Summary Table

Test Case #	Test Scenario	Tech	Band	Antenna	RSI	SAR Limit 1g [W/kg]	Measured 1g SAR[W/kg]	Max averaged time 1g SAR[W/kg]	Test Results
1	Time varying Tx power case 1	LTE	25	Ant B	0	1.6	0.796	0.838	Verified
2		SA/FR1	n77	Ant E	1	1.6	0.347	0.416	Verified
3		UMTS	2	Ant B	0	1.6	0.761	0.705	Verified
4		GSM	GSM 1900	Ant B	0	1.6	0.530	0.454	Verified
5	Time varying Tx power case 2	LTE	25	Ant B	0	1.6	0.796	0.788	Verified
6		SA/FR1	n77	Ant E	1	1.6	0.347	0.470	Verified
7		UMTS	2	Ant B	0	1.6	0.761	0.681	Verified
8		GSM	GSM 1900	Ant B	0	1.6	0.530	0.431	Verified
9	Change in call	LTE	25	Ant B	0	1.6	0.796	0.814	Verified
10	Modulation Change	LTE	25	Ant B	0	1.6	0.796	0.879	Verified
11	Re-selection in call	LTE	25	Ant B	0	1.6	0.796	0.837	Verified
		SA/FR1	n25	Ant B			0.728		
12	Antenna/Band Switching	LTE	25	Ant B	0	1.6	0.796	0.829	Verified
			14	Ant A			0.337		
13	SAR exposure switch	LTE	12	Ant A	0	1.6	0.206	0.331	Verified
		NSA/FR1	n41	Ant B			0.430		
14	Change in RSI	SA FR1	n41	Ant B	0	1.6	0.271	0.385	Verified
					1		0.430		
15	NSA antenna switching with Spatial TAS	LTE	14	Ant A	0	1.6	0.337	0.457	Verified
		NSA/FR1	41	Ant B			0.430		
		NSA/FR1	n77	Ant E			0.347		
16	Intra-Band CA	LTE	41	Ant B	0	1.6	0.360	0.360	Verified
17	Tx power of WLAN TAS (Bluetooth off)	WLAN	2.4G	Ant F	0	1.6	0.424	0.334	Verified
					1		0.408		
18	Tx power of WLAN TAS (Bluetooth on)	WLAN	5G	Ant E	0	1.6	0.252	0.210	Verified
					1		0.188		
19	Tx power of WLAN TAS (Bluetooth on)	WLAN	5G	Ant E	0	1.6	0.252	0.400	Verified
					1		0.188		
		Bluetooth	2.4G	Ant F	0		0.216		

Note:

1. The output power for SAR test in WWAN/WLAN mode of this device is characterized as Head [RSI=1] and Non-Head [RSI=0].
2. The S.LSI TAS algorithm for the main chipset in this DUT has been validated based on the latest S.LSI TAS algorithm update version documents, [OEM][Samsung S.LSI_S5300] Time-averaged SAR algorithm (FCC)_v.3.3 and [OEM [Samsung+S.LSI_S5400]+Time-averaged SAR algorithm+(FCC)_v1.1].
3. The WLAN, Bluetooth chipset of this DUT is based on [Samsung S.LSI_S5E8835] Time-averaged SAR algorithm for Wi-Fi and BT (Customer)_v.1.0.
4. FCC SAR Limit [W/kg]: 1.6W/kg, 1g, The SAR Design Target for Main Band is 1.0W/kg, WLAN/BT mode is 0.7W/kg, and an uncertainty of 1dB is applied to each mode.

5. Both WWAN Mode and WLAN/BT Mode of this DUT are applied with S.LSI TAS algorithm, but they are not interworked with each other, and the output power is controlled by operating the TAS algorithm independently in each mode to meet the FCC limit.

4. Tx Varying Transmission Test Cases and Test Proposal.

In order to validate the TAS algorithm, we propose many test cases to confirm that TAS can ensure the compliance for different operation scenarios. In this section, we explain the reasoning for the selection of test cases and how the performance is validated.

As described in Section 4 the RF exposure is proportional to the Tx power for both sub-6GHz, and WLAN technologies. Thus, we rely on conducted power measurements for sub-6GHz RATs (such as 2G, WCDMA, LTE and FR1), WLAN and Bluetooth power measurements in each dynamic case to demonstrate that overall RF exposure is within the FCC limit. Detailed test case numbering, procedures and test configurations are covered in Sections 5, 7 and 8. The final performance validation results for all test cases are then provided in Sections 8 and 9. Here we provide a general explanation of how the tests carried out and some examples of the way results will be presented.

The overall procedure for validating any test case is summarized below:

1. Measure conducted power for any sub-6GHz RAT (such as LTE and FR1), WLAN and Bluetooth over time, denoted as $TxPower_{sub6GHz}(t)$, and radiated Power EIRP(FR2) over time, denoted as $EIRP_{FR2}(t)$, with time index (t) . These are measured values reported by the power meter referenced back to the UE antenna planes.
2. Convert measured powers to RF exposure values using linear relationship shown below. In below expression, $P_{limit,sub6GHz}$, would be the measured power at which the sub-6GHz technology meets measured SAR level of SAR_{design_target} . Similarly, $P_{limit,FR2}$ would be the measured EIRP at which FR2 technology meets the measured PD level of $PD_{design_targets}$

$$SAR(t) = \frac{TxPower(t)}{P_{limit,FR1}} \times SAR_{design_target}$$

Eqn. (1)

$$PD(t) = \frac{EIRP(t)}{P_{limit,FR2}} \times PD_{design_target}$$

Eqn. (2)

3. Compute the total RF exposure over the most recent measurement duration which are denoted as $T_{SAR,2G}$, $T_{SAR,WCDMA}$, $T_{SAR,LTE}$, $T_{SAR,FR1}$ and T_{PD} for 2G, WCDMA, LTE, FR1 and FR2, respectively. The maximum values for these durations are as specified by FCC. As an example, this total exposure within the measurement duration is given by adding up $SAR_{inst,sub6GHz}(u)$ and $PD_{inst,FR2}(u)$ for different RATs and bands for all time instances u within time intervals such as $[t - T_{SAR,LTE}, t]$, $[t - T_{SAR,FR1}, t]$ and $[t - T_{PD}, t]$ for LTE, FR1 and FR2, respectively.
4. Divide the total RF exposure for sub-6GHz RATs and FR2 by corresponding FCC limit and ensure the sum denoted as $TER(t)$ (or total exposure ratio at time t) is less than 1 for all t . Please refer to the equations in Algorithm operation which describes the detailed calculation of TER and its target constraint.

$$TER(t) = \frac{\sum_{i=SAR=0}^{i=SAR-1} SAR_{avg,iSAR}(t)}{SAR_{limit,FCC}} + \frac{\sum_{i=PD=0}^{i=PD-1} PD_{avg,iPD}(t)}{PD_{limit,FCC}} \leq 1 \quad \text{Eqn. (3)}$$

Since TAS is implemented for different technologies (LTE, NR, WCDMA, and 2G), separate test cases are chosen to show that TAS guarantees the compliance for all supported technologies. We have chosen the test scenarios such that each technology is represented by at least one test case (or a part of a test) that shows its standalone operation using different requested power sequences in a single band.

Usually, the maximum transmit power request at long durations will exercise the TAS algorithm fully to restrict allowed maximum power per window (when $P_{limit} < P_{max}$).

However, some requested transmit power change sequences (in FR1) or beam change (in FR2) are also included to show that TAS maintains SAR/PD usage history in dynamic cases.

Additionally, tests cases are provided for different operations that can occur while still being connected to the same technology (rather than power request change). For example, TC involves inter-Band ULCA operation for FR1, which shows how TAS can handle the different operations of transmitting over two bands simultaneously and the addition/removal of a band/cell.

Other cases that are included to confirm the UE maintains and tracks SAR usage history are call disconnect/re-establishment and also RSI change tests (where P_{limit} can be changed during operation due to device state change). Moreover, UL-MIMO tests are included for rank 2 transmission over two antennas in addition to tests that include switching of operating bands.

Other scenarios include multi-RAT operations where two technologies can transmit simultaneously (such as EN-DC) or there is dynamic switching between each other (during inter-RAT handover). These scenarios include transitions when switching happens between technologies or a RAT/band is added or removed. LTE and NR are chosen with some specific bands to verify TER compliance in different scenarios which have multi-radio operations. Since the TAS operation is band/technology agnostic, only a few combinations are sufficient for testing. As an example, inter-RAT represents a switch of operation from one technology to another while both are not operating simultaneously. For simultaneous transmission of technologies, the EN-DC operation between LTE and FR1 and the NR-DC operation between FR1 and FR2, respectively.

These cases include the different scenarios such as addition/removal of a technology and the simultaneous operation between the two RATs.

Please note that these multi-technology/transmitters operations are the considered as the worst-case scenarios specially during the transitions of operations. To allow a separate TAS for each RAT, the SAR adjustment algorithm that handles the splitting of SAR budget between the RATs should control the increase of SAR allocation at any RAT in a very conservative manner such that compliance is ensured at any moment. In addition, sometime this algorithm enforces harsher actions (like setting lower power levels) if one RAT is consuming high amount SAR or even if this RAT is reducing its consumed SAR slower than the intended rate of SAR reduction. In addition, while ensuring compliance, the SAR adjustment algorithm aims to optimize the operation during transitions to allow a reasonable power level of transmission for both RATs.

In addition, our TAS algorithm supports another feature that can deal with the spatial properties of the antennas which we call Spatial TAS(S-TAS). This feature could boost the transmitted power as it takes into consideration the coupling between the different antennas and bands.

Spatial TAS allows each of two simultaneous transmitters that use two uncoupled antennas to transmit at an average power equal to their P_{limit} values. This means that the total power is doubled while ensuring the compliance. In addition, Spatial TAS has a major benefit for a single transmitter when switching between antennas.

If the antennas are uncoupled, then if the transmission was happening at Ant1 and switched to Ant2, Spatial TAS will start transmission at Ant2 without taking into consideration the consumed SAR at

Ant1. This will enhance the capability of the transmitter at Ant2 to transmit with more power while ensuring that the TER/SAR is below the compliance limit at any time.
Please note that, coupling between antennas depends on the OEM device used. So, the OEM has to construct a coupling matrix that includes the coupling between each two antennas/antenna groups.

For this feature, the test cases are mainly chosen to show how the transmission on uncoupled antennas enhances the transmit power performance while still ensuring RF exposure compliance. The tests are chosen mainly to include multiple antennas transmissions (simultaneous transmission or switching between antennas) with different operations such as EN-DC and inter-band ULCA. For spatial TAS, several test cases are shown where multiple antennas are used for transmission. In summary, the following scenarios are covered in this report to demonstrate compliance with FCC RF exposure in Tx varying transmission conditions.

1. During a time-varying Tx power transmission – to prove that TAS feature accounts for Tx power variations in time accurately.
2. During a call disconnect and re-establish scenario – to prove that the TAS feature accounts for history of Tx power from past accurately
3. During a technology/band handover – to prove that TAS feature accounts for history across transitions in band/technology
4. During RSI (Radio SAR index) change – to prove that TAS feature functions correctly to meet compliance limits across RSI changes
5. During switch in SAR exposure-to prove that TAS feature can handle multi-RAT transmission with transitions in operation.
6. During UL CA-to prove that TAS feature can handle adding/removing CC and can handle both single CC and CA.
7. During UL MIMO-to prove that TAS feature can handle Tx power variations with Rank2 transmission.
8. During usage of Spatial TAS with uncoupled antennas for two transmit scenarios.
9. During usage of 60s averaging in <3GHz FR1 bands in addition to the previously supported 100s duration.

5. SAR Time Averaging Validation Test Procedures

Test Plan and test procedure for validating Samsung S.LSI TAS algorithm for FR1, WLAN and Bluetooth scenarios.

5.1 Test sequence determination for validation

Two sequences for time varying Tx power are pre-defined as given below for FR1 case.

1. Test sequence A which is generated with one or two levels where one of the levels (P_{max}) which is applied at least for 150s. The other level is set at the target power level plus 2dB($P_{limi}(dBm)+2dB$) and it lasts for at least 200s.
2. Test Sequence B is generated at multiple power levels that are specified in the Appendix as a function of P_{max} and P_{limit} .

5.2. Test configuration selection for Validation TAS

This section provides general guidance for selecting test cases in TAS algorithm validation. Modifications of the test cases are possible to study other specific scenarios.

5.2.1 Test configuration selection for time-varying Tx power transmission

The Samsung S.LSI TAS algorithm is independent of band, modes or channel of any technology. Hence, we can validate using one or two combinations of band/mode/channel per technology. The criteria for selecting these would be based on the relative value of P_{limit} and P_{max} as determined in SAR PART 0 Report. Essentially, we need to pick this combination such that P_{limit} is less than P_{max} so that the TAS algorithm will enforce power restriction.

5.2.2 Test configuration selection for change in call

The criteria to select the technology/band for transition between call setup and call drop is to choose the one with least P_{limit} among all bands. The test is performed with DUT requested power at P_{max} so that the Samsung S.LSI TAS feature enforces power restriction for longest duration. The call change is performed when the DUT is operating with restricted power. One such test is sufficient since behavior is not dependent on band/technology.

5.2.3 Test configuration for change in RSI (Radio SAR index)

The criteria for selecting test case to demonstrate compliance across RSI change within a radio. The two RSI states are chosen by pick a technology/band from SAR Part 0 Report such that P_{limit} is less than P_{max} for both states. However, to show the performance of the TAS algorithm in this document, the case of low P_{limit} is considered, which is shown in Table 8.2-1.

5.2.4 Test configuration for change in modulation

The criteria for selecting test case to demonstrate compliance across modulation change within a radio. The two module states are chosen by pick a technology/band from SAR PART 0 Report such that P_{limit} is less than P_{max} for both states. However, to show the performance of the TAS algorithm in this document, the case of low P_{limit} is considered, which is shown in Table 8.2-1.

5.2.5 Test configuration for SAR exposure switching

The criteria for selecting test case is to pick an LTE band and a NR band with P_{limit} lower than P_{max} in each case. The test is performed with both RATs connected in an EN-DC scenario. In the first portion of the test, DUT is requested to transmit at maximum power for NR and minimum power for LTE. In the second portion of the test, DUT is requested to transmit at maximum power for both NR and LTE. In the final portion of the test, DUT is requested to transmit at minimum power for NR and maximum power for LTE.

5.2.6 Test configuration for change in technology/band/antenna

FCC specifies different measurement durations for time averaging based on operating frequency. The criteria for selecting test case to demonstrate compliance is to pick a technology/band/antenna corresponding to antenna groups from SAR PART 0 Report such that P_{limit} is less than P_{max} .

5.2.7 Test configuration for Uplink CA

The criteria for selecting this test case is to demonstrate the compliance of the TAS algorithm when an LTE/NR transmission is done over multiple CC. This test shows that the TAS algorithm compliance is independent on the Transmission scenarios (single CC or CA).

5.2.8 Test configuration for Uplink MIMO

The criteria for selecting test case is to demonstrate the compliance of the TAS algorithm when a rank2 SA FR1 transmission is done over 2 Tx antennas. This test shows that the TAS algorithm compliance by ensuring a total average SAR below the designated compliance level.

5.2.9 Test configuration for NSA antenna switching

The criteria for selecting test case is to pick an LTE band and a NR band with P_{limit} lower than P_{max} in each case. The test is performed with both RATs connected in an EN-DC scenario. In the first portion of the test, DUT is requested to transmit at maximum power for NR and minimum power for LTE. In the second portion of the test, DUT is requested to transmit at maximum power for both NR and LTE. In the final portion of the test, DUT is requested to change the antenna at maximum power for LTE and NR.

5.2.10 Test configuration for NTN

The criteria of selecting this test configuration is to demonstrate that Samsung S.LSI algorithm is independent of bands or technology used. We will show that the algorithm can control the transmitted power of an NTN transmission when a maximum power is requested.

5.2.11 Test configuration for WLAN & Bluetooth

The criteria for selecting test case to demonstrate compliance across RSI change within a radio. The two RSI states are chosen by pick a technology/band from Table 6-1 such that P_{limit} is less than P_{max} for both states. However, to show the performance of the TAS algorithm in this document, the case of low P_{limit} is considered, which is shown in Table 8.2-1.

5.3 Test procedures for conducted power measurements

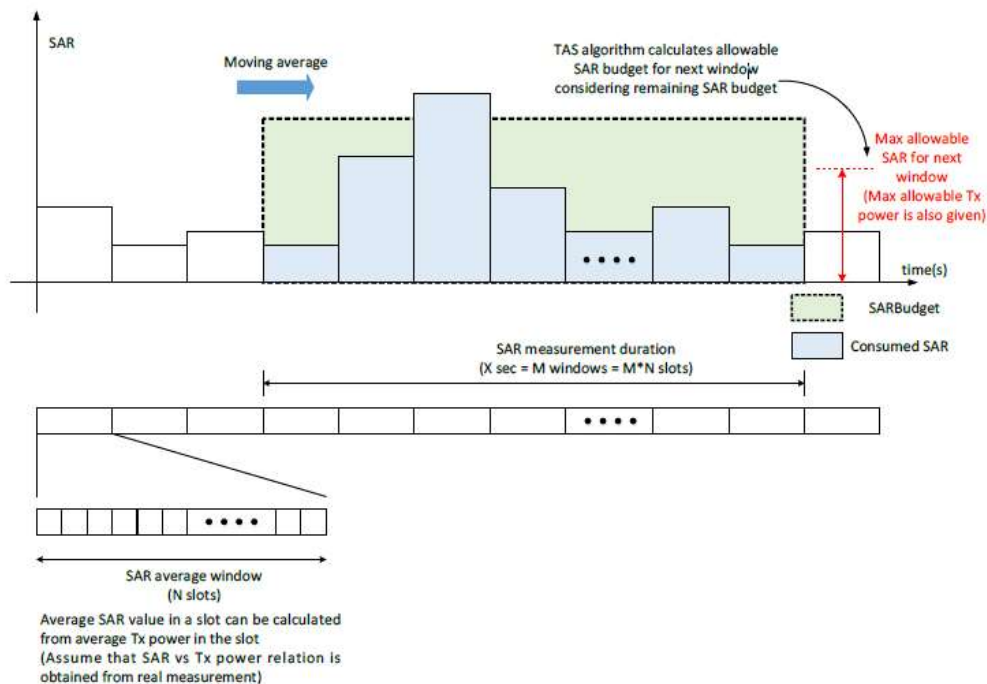
This section provides general conducted power measurement procedures to perform compliance test under dynamic scenarios.

5.3.1 Time-varying Tx power transmission scenario

This test is performed with two pre-defined test sequences as described in Section 5.1 for all technologies operating on sub-6GHz applying to GSM, WCDMA, LTE and FR1. The purpose of the test is to demonstrate the maximum power limiting enforcement and that the time-averaged SAR does not exceed the FCC limit at all times.

5.3.1.1 Test procedure

1. Using the Pmax and Plimit obtained in Table 8.2.1, generate the test sequence of power levels for each selected technology/band. Both test sequences A and B are generated. Maximum power can be changed according to DUT test results.
2. Establish the connection of the DUT to the call box in the selected RAT, with the call box requesting the DUT Tx power to be according to the sequence determined in Step 1. An initial value of Tx power will be set to 0dBm for 60s before the desired test sequence starts to help with post-processing of the time-average value with the very first value in the sequence. This is illustrated in the figure below



3. Release connection.
4. After the completion of the test, prepare one plot with the following information:
 - A. Instantaneous Tx power versus time measured in Step 2
 - B. Requested Tx power versus time used in Step 2
 - C. Time-averaged power over 60s using instantaneous values from Step 2
 - D. Power level Plimit which is determined as meeting SAR target in Table 8.2.1(Pmax Plimit Table)
5. Make a second plot containing the following information:
 - A. Computed time-averaged 1gSAR versus time determined in Step 2
 - B. b. FCC 1gSAR limit of 1.6W/kg

The pass condition is to demonstrate time-averaged 1gSAR versus time shown in Step 5 value versus time does not exceed the FCC limit of 1.6 W/kg throughout the test duration. We would also demonstrate that time-averaged power does not exceed the Plimit at any time in the plot in Step 4.

5.3.2 Change in call scenario

This test is to demonstrate that Samsung S.LSI TAS feature correctly accounts for past Tx powers during time averaging when a new call is established. The call change has to be carried out when the power limit enforcement is ongoing.

5.3.2.1 Test procedure

1. Establish radio connection of DUT with call box e.g. using LTE technology
2. Configure call box to set DUT Tx power to a low value of 0dBm for 60s.
3. Configure call box to send “ALL UP” power control commands and continue LTE transmission from DUT so that maximum power of Pmax is achieved.
4. After 150s of transmission at Pmax power level, release the call from call box.
5. After 10s, re-establish the LTE connection from call box to DUT and repeat sending “ALL UP” power control command to bring the TX power to Pmax level again and continue for 140s
6. Release LTE connection.
7. After the completion of the test, prepare one plot with the following information (a) Instantaneous Tx power versus time (b) Requested Tx power versus time (c) Time-averaged power over 100s using instantaneous values and (d) Power level Plimit which is determined as meeting SAR target
8. Make a second plot containing the following information (a) Computed time-averaged 1gSAR versus time and (b) FCC 1gSAR limit of 1.6W/kg.

Pass condition is to demonstrate time-averaged 1gSAR value versus time does not exceed the FCC limit of 1.6 W/kg throughout the test duration. It is required to check if SAR calculation is accounting for call drop and connection. Current TAS algorithm software makes the UE estimate the exact amount of Tx power and average SAR even during call drop and call re-establishment event. The UE stores time information when it goes into a sleep mode and wake-up to calculate Tx power on / off duration.

5.3.3 Change in technology/band

This test is to demonstrate that Samsung S.LSI TAS feature can properly handle change of technology/band and consequently time window as necessary during handover scenarios. Since both Plimit and window duration can change across bands, we have to use separate equations below for converting Tx power to SAR as well as apply some combined SAR exposure criteria as shown below.

$$SAR_1(t) = \frac{TxPower_1(t)}{P_{limit,1,FR1}} * SAR_design_target_1 \quad (5.3-1)$$

$$SAR_2(t) = \frac{TxPower_2(t)}{P_{limit,2,FR1}} * SAR_design_target_2 \quad (5.3-2)$$

where $P_{limit,1,FR1}$ would correspond to measured power at which first technology/band meets measured SAR level of SAR_design_target as described in Table 8.2.1 with time-averaging duration of T_{1SAR} . Similarly, the quantities $P_{limit,2,FR1}$, $SAR_design_target_2, T_{2,SAR}$ are defined for the second technology/band/antenna/ In this document, 60s is considered for all sub 6GHz including below 3GHz.

5.3.3.1 Test procedure for handover between two TAS RATs

1. Establish radio connection of DUT with call box e.g. using 5G FR1 NR technology
2. Configure call box to set DUT Tx power to a low value of 0dBm for 60s.
3. Configure call box to send “ALL UP” power control commands and continue SA FR1 transmission from DUT so that maximum power of Pmax is achieved. Continue transmission at the maximum power for 150s.
4. Change RAT from NR to LTE and configure call box to send “ALL UP” power control commands in LTE
5. Continue call in LTE at maximum power for 150s.
6. Release LTE connection
7. After the completion of the test, prepare one plot with the following information for each RAT (a) Instantaneous Tx power versus time (b) Time-averaged power for each RAT over 60s using instantaneous values and (c) Power level Plimit which is determined as meeting SAR target
8. Make a second plot containing the following information (a) Computed time-averaged 1gSAR versus time for each RAT (b) Sum of time-averaged SAR computed according to Eqn. (5.3-1) and (5.3-2), and (c) FCC 1g SAR limit of 1.6W/kg

Pass condition is to demonstrate total time-averaged 1gSAR value versus time does not exceed the FCC limit of 1.6 W/kg throughout the test duration. It is required to check if power limiting enforcement is operated as expected when RAT change occurs in-between.

5.3.3.2 Test procedure for band/antenna change

1. Establish radio connection of DUT with call box e.g. using LTE technology.
2. Configure call box to set DUT Tx power to a low value of 0dBm for 60s.
3. Configure call box to send “ALL UP” power control commands and continue LTE Band A transmission from DUT so that maximum power of Pmax is achieved. Continue transmission for 150s.
4. Change band from LTE Band A to LTE Band B and configure call box to send “ALL UP” power control commands in LTE for another 150s.
5. Release LTE connection.
6. After the completion of the test, prepare one plot with the following information for each RAT (a) Instantaneous Tx power versus time (b) Time-averaged power for each RAT over 60s using instantaneous values and (c) Power level Plimit which is determined as meeting SAR target.
7. Make a second plot containing the following information (a) Computed time-averaged 1gSAR versus time for each RAT (b) Sum of time-averaged SAR computed according to Eqn. (5.3-1) and (5.3-2), and (c) FCC 1gSAR limit of 1.6W/kg.

Pass condition is to demonstrate total time-averaged 1gSAR value versus time does not exceed the FCC limit of 1.6 W/kg throughout the test duration. It is required to check if power limiting enforcement is operated as expected when band/antenna change occurs in-between.

5.3.4 Change in RSI

This test is to demonstrate that Samsung S.LSI TAS feature can properly handle change of RSI resulting from different SAR index state detected by host platform software. It involves changing the Plimit value during the test for the same technology to emulate RSI change, while the SAR_design_target remains the same. Note that the DUT has a Hotspot mode to manage body exposure, which is represented using RSI = 0, the head exposure can be distinguished through audio receiver mode, represented as RSI = 1.

5.3.4.1 Test procedure for change in RSI

1. Establish radio connection of DUT with call box e.g. using NR SA FR1
2. Configure DUT to send at low Tx power of 0 dBm for 60s and set the RSI index corresponding to Plimit.
3. Configure call box to send "ALL UP" power control commands and continue SA FR1 transmission from DUT so that maximum power of Pmax is achieved. Continue the transmission for 150s.
4. Change the RSI index corresponding to lower value and continue the transmission for another 150s
5. Release the SA FR1 connection.
6. After the completion of the test, prepare one plot with the following information (a) Instantaneous Tx power versus time (b) Time-averaged power over 60s using instantaneous values and (c) Power level Plimit which is determined as meeting SAR target
7. Make a second plot containing the following information (a) Computed time-averaged 1gSAR versus time and (b) FCC 1gSAR limit of 1.6W/kg

Pass condition is to demonstrate time-averaged 1gSAR value versus time does not exceed the FCC limit 1.6 W/kg throughout the test duration. It is required to check if power limiting enforcement is operated as expected when RSI index is changed during the test.

5.3.5 SAR exposure switching

This test is to demonstrate that Samsung S.LSI TAS feature can properly handle change of dominant SAR exposure radio in the case of two simultaneous active RATs. It involves changing the required power of both radios such that either one or both of the RATs becomes dominant contributor to total exposure ratio at different times of the test.

5.3.5.1 Test procedure for SAR exposure switching

1. Establish LTE and NR radio connection in NSA case with both call boxes, e.g. LTE and NR FR1 Technology.
2. Configure the LTE and NR call box to set DUT Tx power to a low value of 0dBm for 60s.
3. Configure the NR call box to send “ALL UP” power control commands and continues transmission from DUT so that maximum power of Pmax is achieved. Continue transmission for 150s
4. In the second part of test configure the LTE call box to send “ALL UP” power control commands and all transmissions are continued, resulting in maximum power requested from DUT for both LTE and NR. This stage of test is continued for another 150s.
5. In the third part of test, configure the NR call box to send “ALL DOWN” power control commands so that LTE becomes the dominant SAR radio. This stage is continued for another 150s.
6. Release the both LTE and NR connections.
7. After the completion of the test, prepare one plot with the following information (a) Instantaneous Tx power versus time (b) Time-averaged power over 60s using instantaneous values and (c) Power level P_{limit} which is determined as meeting SAR target.
8. Make a second plot containing the following information (a) Computed time-averaged 1gSAR versus time and (b) FCC 1gSAR limit of 1.6W/kg.

Pass condition is to demonstrate total time-averaged 1gSAR value versus time does not exceed the FCC limit of 1.6 W/kg throughout the test duration. It is required to check if power limiting enforcement is operated as expected when dominant power is changed in EN-DC.

5.3.6 Test procedure for NSA antenna switching

This test is to demonstrate that Samsung S.LSI TAS feature can properly handle change of NSA antenna switching in the case of two simultaneous active RATs. It involves changing the Tx antenna of both radios such that either one or both of the RATs becomes dominant contributor to total exposure ratio at different times of the test.

5.3.6.1 Test procedure

1. Establish LTE and NR radio connection in NSA case with both call boxes, e.g. LTE and NR FR1 Technology.
2. Configure the LTE and NR call box to set DUT Tx power to a low value of 0dBm for 60s.
3. Configure the LTE call box to send “ALL UP” power control commands and continues transmission from DUT so that maximum power of Pmax is achieved. Continue transmission for 150s.
4. In the second part of test, configure the NR call box to send “ALL UP” power control commands and all transmissions are continued, resulting in maximum power requested from DUT for both LTE and NR. This stage of test is continued for another 150s.
5. In the third part of test, change band from NR SA FR1 on AG0 to AG1 and configure call box to send “ALL UP” power control commands in NR for another 150s.
6. Release the both LTE and NR connections.
7. After the completion of the test, prepare one plot with the following information (a) Instantaneous Tx power versus time (b) Time-averaged power over 60s using instantaneous values and (c) Power level P_{limit} which is determined as meeting SAR target.
8. Make a second plot containing the following information (a) Computed time-averaged 1gSAR versus time and (b) FCC 1gSAR limit of 1.6W/kg.

Pass condition is to demonstrate total time-averaged 1gSAR value versus time does not exceed the FCC limit of 1.6 W/kg throughout the test duration. It is required to check if power limiting enforcement is operated as expected when Tx antenna is changed in EN-DC

5.3.7 Uplink CA

The test is to demonstrate that Samsung S.LSI TAS feature can properly handle the SAR exposure for LTE/NR with the addition and/or removal of another intra-band LTE/NR CC

5.3.7.1 Test procedure for intra-band uplink CA

1. Establish LTE connection of DUT with call box over Cell 1 E.g. one cell of the band Combo CA.
2. Configure the call box to set DUT Tx power to a low value of 0dBm for 60s.
3. Configure Call box to send "ALL UP" power control commands and continue transmission from DUT so that maximum power of Pmax is achieved. Continue transmission for 150s
4. Establish LTE connection of DUT with call box over Cell 2 E.g. other cell of the band Combo CA and configure call box to send "ALL UP" power control command on cell 2 for 150s.
5. Release LTE connection for both cells
6. After the completion of the test, prepare one plot with the following information (a) Instantaneous Tx power versus time (b) Time-averaged power over 60s using instantaneous values and (c) Power level Plimit which is determined as meeting SAR target.
7. Make a second plot containing the following information (a) Computed time-averaged 1gSAR versus time and (b) FCC 1gSAR limit of 1.6W/kg.

Pass condition is to demonstrate total time-averaged 1gSAR value versus time does not exceed the FCC limit of 1.6 W/kg throughout the test duration. It is required to check if power limiting enforcement is operated as expected when intra-band change occurs.

5.3.7.2 Test procedure for inter-band uplink CA

1. Establish LTE/NR connection of DUT with callbox PCC
2. Configure call box to set DUT Tx power to a low value of 0dBm for 60s.
3. Configure call box to send “ALL UP” power control commands and continue transmission from DUT so that maximum power of Pmax is achieved. Continue transmission for 150s.
4. Establish an inter-band ULCA connection by attaching a secondary cell connection SCC and configure call box to send “ALL UP” power control commands for 150s.
5. Release the LTE/NR connection
6. After the completion of the test, prepare one plot with the following information (a) Instantaneous Tx power versus time (b) Time-averaged power over 60s using instantaneous values and (c) Power level P_{limit} which is determined as meeting SAR target.
7. Make a second plot containing the following information (a) Computed time-averaged 1gSAR versus time and (b) FCC 1gSAR limit of 1.6W/kg.

Pass condition is to demonstrate total time-averaged 1gSAR value versus time does not exceed the FCC limit of 1.6 W/kg throughout the test duration. It is required to check if power limiting enforcement is operated as expected when inter-band change occurs.

5.3.8 Change in modulation change scenario

This test is to demonstrate that Samsung S.LSI TAS feature correctly accounts for past Tx powers during time-averaging when a new call is established. The call change has to be carried out when the power limit enforcement is ongoing.

5.3.8.1 Test procedure

1. Establish radio connection of DUT with call box e.g. using LTE technology.
2. Configure call box to set DUT Tx power to a low value below 0dBm for 60s.
3. Configure call box to send “ALL UP” power control commands and continue LTE transmission from DUT so that maximum power of P_{max} is achieved. Continue the transmission for 150s.
4. Change the modulation from QPSK to 16QAM from call box and continued the transmission for another 150s.
5. Release LTE connection.
6. After the completion of the test, prepare one plot with the following information (a) Instantaneous Tx power versus time (b) Time-averaged power over 60s using instantaneous values and (c) Power level P_{limit} which is determined as meeting SAR target.
7. Make a second plot containing the following information (a) Computed time-averaged 1gSAR versus time and (b) FCC 1gSAR limit of 1.6W/kg.

Pass condition is to demonstrate time-averaged 1gSAR value versus time does not exceed the FCC limit of 1.6 W/kg throughout the test duration. It is required to check if SAR calculation is accounting for modulation change. Current TAS algorithm software makes the UE estimate the exact amount of Tx power and average SAR even during modulation change event.

5.4 Spatial TAS

For the test cases with spatial TAS, we will consider 3 antennas (Ant A, B and E) with two antenna groups where each antenna group consists of two antennas and multiple bands as in Table 5.4-1.

Table 5.4-1 Antennas and bands used in the spatial TAS conducted tests

AG#	Antenna	Band
AG0	Ant A, Ant B	GSM 1900, WCDMA B2, LTE B12, LTE B14, LTE B25, LTE B41, NR n25, NR n41
AG1	Ant E	NR n77

The coupling matrix considered during the tests is

$$R = \begin{bmatrix} 1 & 0 \\ 0 & 1 \end{bmatrix}$$

5.5 WLAN and Bluetooth

5.5.1 Test procedure for WLAN (Bluetooth off)

1. Establish WLAN connection of DUT with call box.
2. Set DUT TAS algorithm Enable.
3. Configure to set DUT so that Plimit Power[RSI=0] for 360s
4. After Configure to set DUT so that Plimit Power[RSI=1] for 360s
5. Release WLAN connection.
6. After the completion of the test, prepare one plot with the following information (a) Instantaneous Tx power versus time (b) Time-averaged power over 60s using instantaneous values and (c) Power level Plimit which is determined as meeting SAR target.
7. Make a second plot containing the following information (a) Computed time-averaged 1gSAR versus time and (b) FCC 1gSAR limit of 1.6W/kg.

Pass condition is to demonstrate time-averaged 1gSAR value versus time does not exceed the FCC limit of 1.6 W/kg throughout the test duration.

5.5.2 Test procedure for WLAN (Bluetooth on)

1. Establish WLAN connection of DUT with call box.
2. Set DUT TAS algorithm Enable.
3. Configure to set DUT so that Plimit Power[RSI=0] for 180s
4. Establish Bluetooth connection of DUT with call box
5. Continue connection for 180s simultaneously
6. Configure to set DUT so that Plimit Power[RSI=1] for 180s with Bluetooth connection
7. Release Bluetooth connection and continue WLAN[RSI=1] connection for 180s
8. Release WLAN connection.
9. After the completion of the test, prepare one plot with the following information (a) Instantaneous Tx power versus time (b) Time-averaged power over 60s using instantaneous values and (c) Power level Plimit which is determined as meeting SAR target.
10. Make a second plot containing the following information (a) Computed time-averaged 1gSAR versus time and (b) FCC 1gSAR limit of 1.6W/kg.

Pass condition is to demonstrate time-averaged 1gSAR value versus time does not exceed the FCC limit of 1.6 W/kg throughout the test duration.

6. Test Configurations

Plim values in green indicate Plimit < Pmax			lim values in grey indicate Plim > Pma			
Plimit corresponding to 1 W/kg (1g) SAR_Design_target					Pmax	
SAR Exposure Position			Body-worn	Head (RCV ON)	Hotspot (Hotspot on)	Maximum Tune-up Output Power (Frame Averaged Power) [dBm]
Averaging volume			1g	1g	1g	
seperation Distance			5 mm	0 mm	5 mm	
Mode	Band	Antenna	Non Head	Head	Non Head	
GSM/GPRS/EDGE	850	Ant.A	22.8	31.1	22.8	24.8
GSM/GPRS/EDGE	1900	Ant.B	16.8	29.6	16.8	21.8
UMTS	2	Ant.B	18.0	28.2	18.0	22.7
UMTS	4	Ant.B	19.0	34.0	19.0	23.0
UMTS	5	Ant.A	20.0	31.7	20.0	23.7
LTE FDD	25(2)	Ant.B	18.0	29.0	18.0	24.0
LTE FDD	2 Upper	Ant.D	20.0	20.0	20.0	24.0
LTE FDD	4,66	Ant.B	19.0	31.1	19.0	24.0
LTE FDD	66(4) Upper	Ant.D	19.0	19.0	19.0	24.0
LTE FDD	7	Ant.B	18.0	30.3	18.0	23.0
LTE FDD	12	Ant.A	20.0	31.4	20.0	24.0
LTE FDD	13	Ant.A	20.0	31.9	20.0	24.0
LTE FDD	14	Ant.A	20.0	31.6	20.0	24.0
LTE FDD	26(5)	Ant.A	19.0	33.8	19.0	24.0
LTE FDD	30	Ant.B	18.0	29.2	18.0	23.0
LTE TDD PC3	41(38)	Ant.B	16.0	32.3	16.0	22.0
LTE TDD PC3	48	Ant.E	17.0	17.0	17.0	19.0
LTE FDD	71	Ant.A	20.0	32.7	20.0	24.0
NR FDD	25(2)	Ant.B	18.5	28.8	18.5	24.0
NR FDD	2 Upper	Ant.D	19.0	19.0	19.0	24.0
NR FDD	5	Ant.A	19.0	32.4	19.0	24.0
NR FDD	30	Ant.B	18.0	30.3	18.0	23.0
NR FDD	66	Ant.B	19.0	31.0	19.0	24.0
NR FDD	66 Upper	Ant.D	19.0	19.0	19.0	23.0
NR FDD	71	Ant.A	19.0	33.0	19.0	24.0
NR TDD	41 PC2	Ant.B	16.0	35.8	16.0	26.0
NR TDD	41 PC3	Ant.B	16.0	35.8	16.0	23.5
NR TDD	48	Ant.E	17.0	17.0	17.0	21.0
NR TDD SRS 2	48 SRS2	Ant.H	13.5	13.5	13.5	19.5
NR TDD SRS 3	48 SRS3	Ant.B	14.0	14.0	14.0	20.0
NR TDD SRS 4	48 SRS4	Ant.I	13.0	13.0	13.0	19.0
NR TDD	77 PC2	Ant.E	16.0	16.0	16.0	25.5
NR TDD SRS 2	77 PC2 SRS2	Ant.H	13.0	13.0	13.0	23.0
NR TDD SRS 3	77 PC2 SRS3	Ant.B	14.5	14.5	14.5	23.0
NR TDD SRS 4	77 PC2 SRS4	Ant.I	12.5	12.5	12.5	22.0
NR TDD	77 DoD PC2	Ant.E	16.0	16.0	16.0	25.5
NR TDD SRS 2	77 DoD PC2 SRS2	Ant.H	13.0	13.0	13.0	23.0
NR TDD SRS 3	77 DoD PC2 SRS3	Ant.B	14.5	14.5	14.5	23.0
NR TDD SRS 4	77 DoD PC2 SRS4	Ant.I	12.5	12.5	12.5	22.0
NR TDD	77(78) PC3	Ant.E	16.0	16.0	16.0	23.0
NR TDD SRS 2	77(78) PC3 SRS2	Ant.H	13.0	13.0	13.0	21.5
NR TDD SRS 3	77(78) PC3 SRS3	Ant.B	14.5	14.5	14.5	21.5
NR TDD SRS 4	77(78) PC3 SRS4	Ant.I	12.5	12.5	12.5	21.0
NR TDD	77(78) DoD PC3	Ant.E	16.0	16.0	16.0	23.0
NR TDD SRS 2	77(78) DoD PC3 SRS2	Ant.H	13.0	13.0	13.0	21.5
NR TDD SRS 3	77(78) DoD PC3 SRS3	Ant.B	14.5	14.5	14.5	21.5
NR TDD SRS 4	77(78) DoD PC3 SRS4	Ant.I	12.5	12.5	12.5	21.0
WLAN	2.4	Ant.F	14.0	16.0	14.0	19.0
WLAN	5	Ant.E	13.0	13.0	13.0	17.0
BT	2.4	Ant.F	17.0	23.2	15.7	12.0

Table 6-1

Note:

1. Radio SAR indicator (RSI) in the table above means the SAR test configuration of each mobile communication technology.
2. WWAN Mode and WLAN/BT mode are both controlled by The Samsung S.LSI proprietary TAS (Time Average SAR) algorithm. but they are not interworked with each other, and the output power is controlled by operating the TAS algorithm independently in each mode to meet the FCC limit.
3. Plimit and Tune up output power Pmax above table correspond to average power level accounting for duty cycle in the case of TDD Modulation schemes (GSM,LTE TDD)
4. Maximum tune up output Power Pmax is used to configure DUT during RF tune up procedure. The maximum allowed output power is equal to Tune up power +1 dB device design uncertainty.
5. Compared with the Plimit (Tune up Powers) declared in each RSI by the manufacturer and the Plimit (calculation) calculated by the SAR measurement of each RSI, the lower power is applied to the DUT as the Plimit at each RSI configurations.

7. Test case list

7.1 Test case list for sub-6GHz transmissions

To validate TAS algorithm in various sub-6GHz conditions, the chosen TC(Test Case) list is defined as in Table 7.1-1

Table 7.1-1 Sub-6GHz TAS validation test case list

No.	Test Scenario	Test case	Test configuration
TC01	Time-varying Tx power transmission	Time_Varying_Tx_Power_Case_1(LTE)	LTE 25
TC02		Time_Varying_Tx_Power_Case_1(NR)	NR n77
TC03		Time_Varying_Tx_Power_Case_1(WCDMA)	UMTS 2
TC04		Time_Varying_Tx_Power_Case_1(2G)	GSM 1900
TC05		Time_Varying_Tx_Power_Case_2(LTE)	LTE 25
TC06		Time_Varying_Tx_Power_Case_2(NR)	NR n77
TC07		Time_Varying_Tx_Power_Case_2(WCDMA)	UMTS 2
TC08		Time_Varying_Tx_Power_Case_2(2G)	GSM 1900
TC09	Change in call	LTE_Call_Disconnect_Reestablishment	LTE 25
TC10	Modulation Chage	LTE_Moudulation_Change	LTE 25
TC11	Re-selection in call	SA_FR1_to_LTE_RAT_Re-relection_Coupling_Case	NR n25, LTE 25
TC12	Antenna/Band switching	LTE_Antenna_Band_Swithcing_Coupling_Case	LTE 25, LTE 14
TC13	SAR exposure switch	NSA_FR1_Dominant_Power_Switching	LTE 12, NR n41
TC14	Change in RSI	SA_FR1_RF_SAR_Index_Change	NR n41
TC15	NSA antenna switching with Spatial TAS	NSA_Ant_switching_Spatial_TAS	LTE 14, NR n41, NR n77
TC16	Inter-band ULCA	LTE_Intra_Band_UL_CA	LTE 41

7.2 Test case list for WLAN/Bluetooth transmissions

To validate TAS algorithm in WLAN/Bluetooth conditions, the chosen TC(Test Case) list is defined as in Table 7.2-1

Table 7.2-1 WLAN/Bluetooth TAS validation test case list

No.	Test Scenario	Test case	Test configuration
TC17	Tx Power of WLAN TAS (Bluetooth off)	TX Power of WLAN TAS(WLAN 2.4G)	WLAN 2.4G
TC18		TX Power of WLAN TAS(WLAN 5G)	WLAN 5G
TC19	Tx Power of WLAN TAS (Bluetooth on)	TX Power of WLAN TAS(WLAN 5G/Bluetooth)	WLAN 5G/Bluetooth

8. Conducted Power Test Results for TAS validation

8.1 Measurement set-up

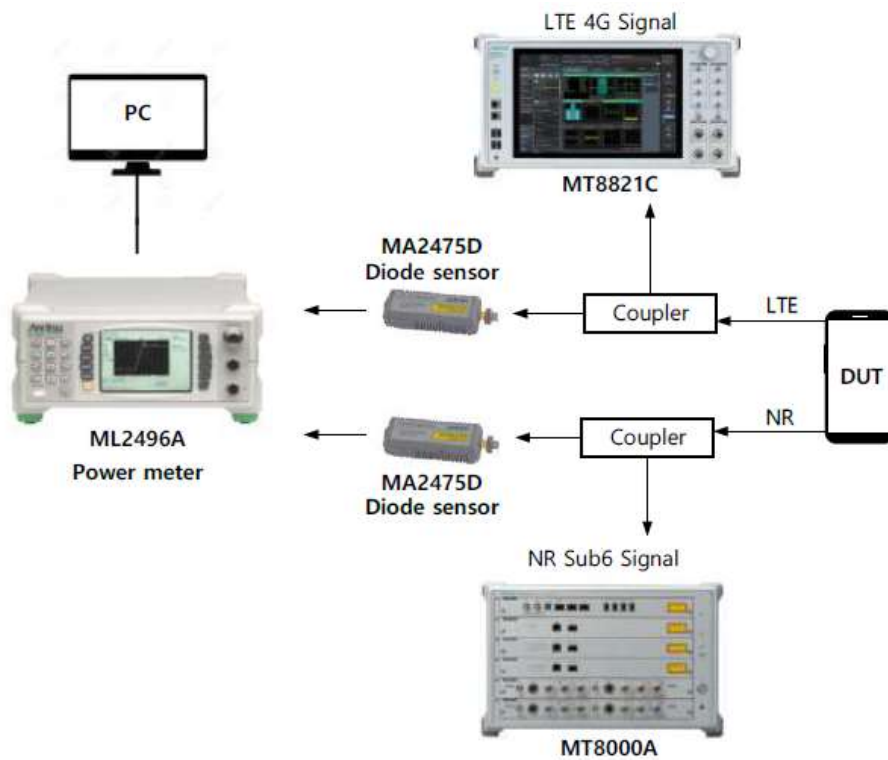


Figure 8.1-1 Test set-up for legacy and sub 6GHz

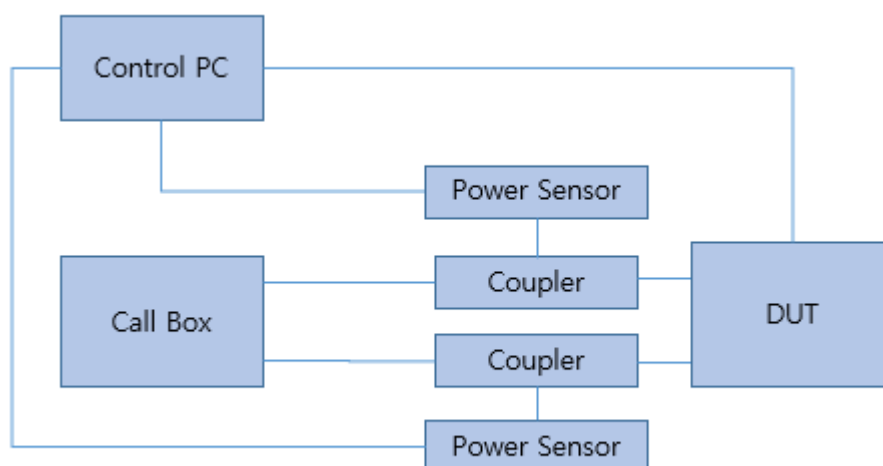


Figure 8.1-2 Test set-up for WLAN and Bluetooth

8.1.1 Test set-up for legacy and sub 6GHz

The test setup for TAS validation with sub-6GHz RATs only is shown in Figure 8.1-1. Normally, a power sensor would measure total power in the entire frequency of its specification e.g. 10MHz to 50GHz for the MA2475D unit. However, when two radios are active, we need to measure their powers separately for using the corresponding SAR mapping table. Therefore, this test setup considers scenarios where two radios would be transmitting from different ports of the DUT so that separate power sensors measure them individually. A common power meter is able to display and record the readings for each sensor at the same time for post processing at a PC. The signaling call boxes MT8000A and MT8821C are used to establish the call and data connection to the DUT on those same ports for NR and LTE, respectively.

The couplers are able to provide the transmit signal from DUT to power sensors while uplink and downlink signaling messages exchanged with the call boxes on the same paths. We can build scripts to program a certain sequence of power control commands from the call boxes to the DUT which can essentially instruct the DUT to change its transmit power.

Thus, if we want DUT to transmit at maximum power in LTE, then continuous power up commands are sent by MT8821C. Similarly, continuous power up commands from MT8000A will try to increase NR power up to its maximum limit. Other power control scenarios which mimic real field behavior such as sequence of power up followed by power down are also possible as described in Section 4. All the path losses from RF port of DUT to the callbox and the power meters are calibrated and automatically entered as offsets in the callbox and power meter, which are also connected to the control PC used in the test setup. We use an Anritsu AMS tool, which is capable of executing the entire test sequence including requested power variation over time and call setup/disconnect scenarios based on pre-configured test case definition.

Power readings for each active technology are recorded every 100ms and dumped in an excel file. A post processing tool is used to extract data from the excel file and plot the required metrics such as time-averaged power, SAR values versus time as described in Section 4.

In summary, the tests have to be executed as following procedure.

1. Measure conduction sub 6GHz Tx power corresponds to SAR regulation.
2. Set sub 6GHz power level with some margin. And start the test
3. Execute time-varying test scenarios. And record sub 6GHz power using sub 6GHz power meter equipment.
4. Plot the recorded results over measurement time. And evaluate the results for validation.

Note that Plimit is different according to the used OEM, so it is necessary to set the Plimit suitable for each terminal.

8.1.2 Test set-up for WLAN and Bluetooth

The test setup for TAS validation with WLAN and Bluetooth is shown in Figure 8.1-2. Normally, a power sensor would measure total power in the entire frequency of its specification e.g. 10MHz to 8GHz for the NRP8S unit. However, when two radios are active, we need to measure their powers separately for using the corresponding SAR mapping table. Therefore, this test setup considers scenarios where two radios would be transmitting from different ports of the DUT so that separate power sensors measure them individually. A common power meter is able to display and record the readings for each sensor at the same time for post processing at a PC. The signaling call box CMW500 is used to establish the call and data connection to the DUT on those same ports for WLAN and Bluetooth, respectively.

The couplers are able to provide the transmit signal from DUT to power sensors while uplink and downlink signaling messages exchanged with the call boxes on the same paths. We can build scripts to program a certain sequence of power control commands from the call box to the DUT which can essentially instruct the DUT to change its transmit power.

Power readings for each active technology are recorded every 100ms and dumped in an excel file. A post processing tool is used to extract data from the excel file and plot the required metrics such as time-averaged power.

In summary, the tests have to be executed as following procedure.

1. Measure conduction WLAN and Bluetooth Tx power corresponds to SAR regulation.
2. Start the test
3. Execute time-varying test scenarios. And record power using power meter equipment.
4. Plot the recorded results over measurement time. And evaluate the results for validation.

Note that Plimit is different according to the used OEM, so it is necessary to set the Plimit suitable for each terminal.

8.2 *Plimit* and *Pmax* measurement results

The measured *Plimit* for all the selected radio configurations are listed in Table 8.2.1. *Pmax* was also measured for radio configurations selected for testing time-varying Tx power transmission scenario in order to generate test sequences following the test procedures. Note that Table 8.2.1 is not actual *Plimit* corresponding to 1W/kg SAR for Sub 6 and 0.7W/kg SAR for WLAN/Bluetooth, but our measured averaged power when forcing *Plimit* in our SW based on Table 8.2.1.

TC#	Test scenario	Tech	Band	Antenna	RSI	RB/offset/BW	Mode	Configuration	Plimit setting (dBm)	Pmax setting (dBm)	measured Plimit (dBm) Sensor	measured Pmax (dBm) Sensor	measured		TAS
													SAR		
													(W/kg)	(W/kg)	
1	Time varying Tx power case 1	LTE	25	B	0	1/0/20MHz	QPSK	1g5mm/Non Head	18.5	24.0	17.73	23.98	0.796	0.838	
2		SA/FR1	n77	E	1	1/27/1/100MHz	DFT-s QPSK	1g5mm/Non Head	16.0	25.5	15.48	25.37	0.347	0.329	
3		UMTS	2	B	0	-	RMC	1g5mm/Non Head	18.0	22.7	17.64	22.83	0.761	0.705	
4		GSM	GSM 1900	B	0	-	4TX	1g5mm/Non Head	20.0	25.0	19.77	24.40	0.530	0.454	
5	Time varying Tx power case 2	LTE	25	B	0	1/0/20MHz	QPSK	1g5mm/Non Head	18.5	24.0	17.73	23.98	0.796	0.788	
6		SA/FR1	n77	E	1	1/27/1/100MHz	DFT-s QPSK	1g5mm/Non Head	16.0	25.5	15.48	25.37	0.347	0.372	
7		UMTS	2	B	0	-	RMC	1g5mm/Non Head	18.0	22.7	17.64	22.83	0.761	0.681	
8		GSM	GSM 1900	B	0	-	4TX	1g5mm/Non Head	20.0	25.0	19.77	24.40	0.530	0.431	
9	Change in Call	LTE	25	B	0	1/0/20MHz	QPSK	1g5mm/Non Head	18.5	24.0	17.73	23.98	0.796	0.814	
10	Modulation Chage	LTE	25	B	0	1/0/20MHz	QPSK	1g5mm/Non Head	18.5	24.0	17.73	23.98	0.796	0.796	
11	Re-selection in call	LTE	25	B	0	1/0/20MHz	QPSK	1g5mm/Non Head	18.5	24.0	17.73	23.98	0.796	0.837	
		SA/FR1	n25	B		1/1/40MHz	DFT-s QPSK	1g5mm/Non Head	18.5	24.0	18.07	24.31	0.728		
12	Antenna/Band switching	LTE	25	B	0	1/0/20MHz	QPSK	1g5mm/Non Head	18.5	24.0	17.73	23.98	0.796	0.829	
			14	A		1/24/10MHz	QPSK	1g5mm/Non Head	20.0	24.0	19.28	23.68	0.337		
13	SAR exposure switch	LTE	12	A	0	1/0/10MHz	QPSK	1g5mm/Non Head	20.0	24.0	20.05	23.84	0.206	0.331	
		NSA/FR1	n41	B		1/27/1/100MHz z	DFT-s QPSK	1g5mm/Non Head	16.0	26.0	15.98	25.84	0.430		
14	Change in RSI	SA FR1	n41	B	1	1/27/1/100MHz z	DFT-s QPSK	1g0mm/Head	26.0	26.0	25.71	25.71	0.271	0.385	
						1g5mm/Non Head	16.0				16.20	25.71	0.430		
15	NSA antenna switching with Spatial TAS	LTE	14	A	0	1/24/10MHz	QPSK	1g5mm/Non Head	20.0	24.0	19.28	23.68	0.337	0.457	
		NSA/FR1	41	B		1/27/1/100MHz z	DFT-s QPSK	1g5mm/Non Head	16.0	26.0	15.98	25.84	0.430		
		NSA/FR1	n77	E		1/27/1/100MHz	QPSK	1g5mm/Non Head	16.0	25.5	15.48	25.37	0.347		
16	Intra-band ULCA	LTE	41	B	0	1/1/20MHz 1/99/20MHz	QPSK	1g5mm/Non Head	16.0	22.0	16.78	22.23	0.360	0.360	
17	Tx Power of WLANTAS Test(Bluetooth off)	WLAN	2.4GHz	F	0	-	1Mbps	1g5mm/Non Head	14.0	19.0	14.93	19.18	0.424	0.334	
				1	1g0mm/Head			16.0			16.79		0.408		
				0	1g5mm/Non Head			13.0			13.96		0.252		
18	Tx Power of WLANTAS Test(Bluetooth on)	WLAN	5GHz	E	0	-	MCS0	1g0mm/Head	13.0	14.0	13.96	14.23	0.188	0.210	
				1	1g5mm/Non Head			13.0			13.96		0.252		
				1	1g0mm/Head			13.0			13.96		0.188		
19	Tx Power of WLANTAS Test(Bluetooth on)	WLAN	5GHz	E	0	-	MCS0	1g0mm/Head	13.0	14.0	13.96	14.23	0.188	0.400	
		Bluetooth	2.4GHz	F	0,1			-	DH-5		1g0mm/Head	12.0	12.0		11.85

Table 8.2.1.

* *Plimit* and Tune up output power *Pmax* in above table correspond to average power level after accounting for duty cycle in the case of TDD Modulation schemes (GSM, LTE TDD, NR TDD, WLAN, Bluetooth)

8.3 Time-varying Tx power measurement results

Time-varying Tx power test case can be skipped if measured SAR value in Pmax is less than 90% of target SAR limit. This is because even if Pmax is used for all times, used SAR cannot be reached to the target SAR limit. Following the test procedure in Section 5.3.1, the conducted Tx power measurement results for all selected test cases are listed in this Section. In all conducted Tx power plots, the blue line shows the measured instantaneous power using the power meter, the red line shows the time-averaged Tx power and yellow line shows the Plimit value corresponding to design target. In all SAR plots, the dotted blue line shows the time-averaged 1gSAR while the red line shows the corresponding FCC limit of 1.6W/Kg. Time-varying Tx power measurements were conducted for TC #01 and #02 in Table 8.2-1 by generating the test sequence A or B given in Appendix.

TC01: Time_Varying_Tx_Power_Case_1 [LTE B25]

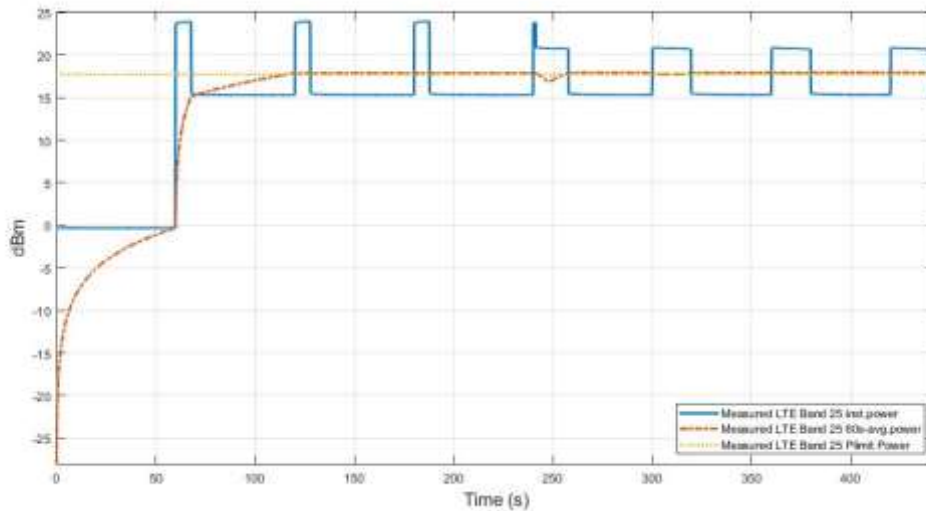


Figure 8.3-1 Time average conducted power of LTE B25 in TC01

In this test, measured 1g SAR would be 0.796 W/kg at 18.5 dBm. Figure 8.3-1 shows the instantaneous and time-averaged Tx power with test sequence A for LTE B25 with Plimit 18.5 dBm. In addition, Figure 8.3-1 shows that the moving-average Tx power is around the targeted Plimit value but it is acceptable result due to uncertainty. Also Figure 8.3-2 shows the calculated time-averaged 1gSAR for this test demonstrating that exposure is well below the FCC limit of 1.6W/kg.

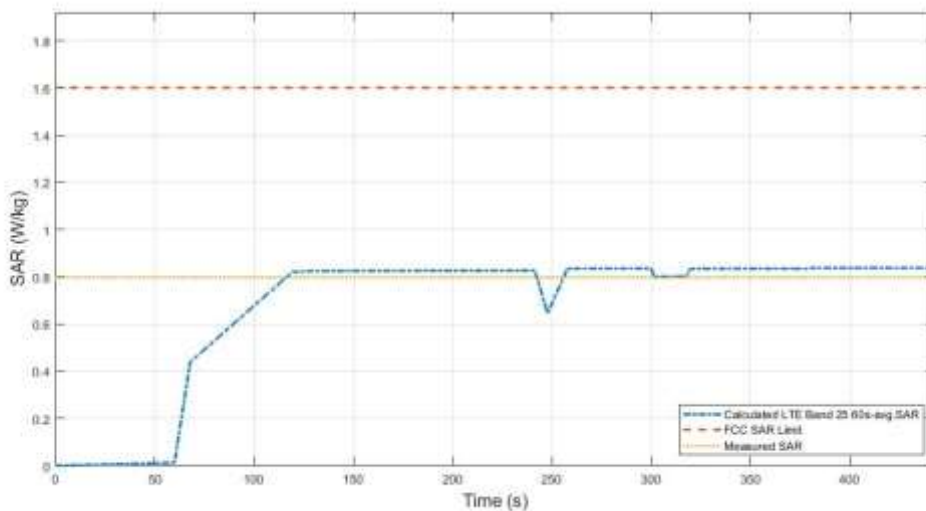


Figure 8.3-2 Total time-averaged SAR in TC01

FCC 1gSAR limit	1.6 W/kg
Max 60s-time average 1gSAR (blue curve)	0.838 W/kg
Device uncertainty	1 dB

TC02: Time_Varying_Tx_Power_Case_1 [NR n77]

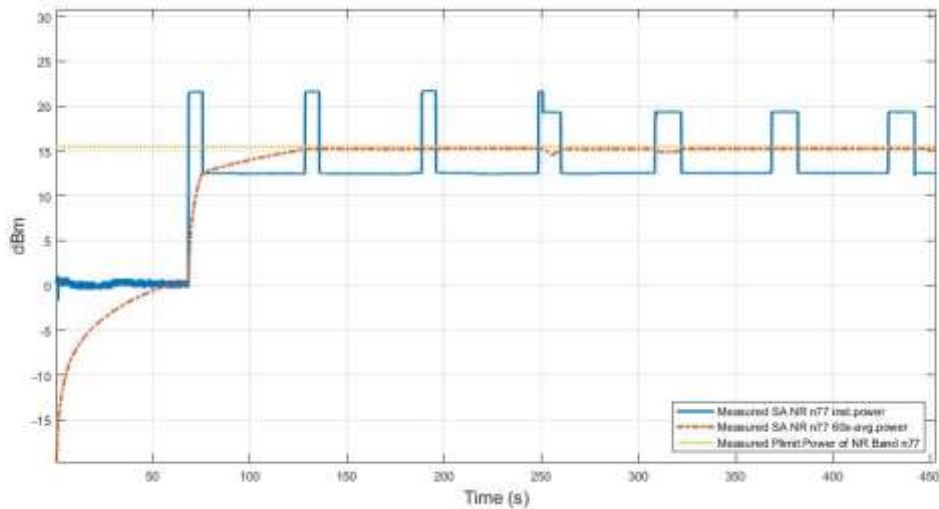


Figure 8.3-3 Time average conducted power of NR n77 in TC02

In this test, measured 1g SAR would be 0.347 W/kg at 16.0 dBm. Figure 8.3-3 shows the instantaneous and time-averaged Tx power with test sequence A for NR n77 with Plimit 16.0 dBm. In addition, Figure 8.3-3 shows that the moving-average Tx power is around the targeted Plimit value but it is acceptable result due to uncertainty. Also Figure 8.3-4 shows the calculated time-averaged 1gSAR for this test demonstrating that exposure is well below the FCC limit of 1.6W/kg.

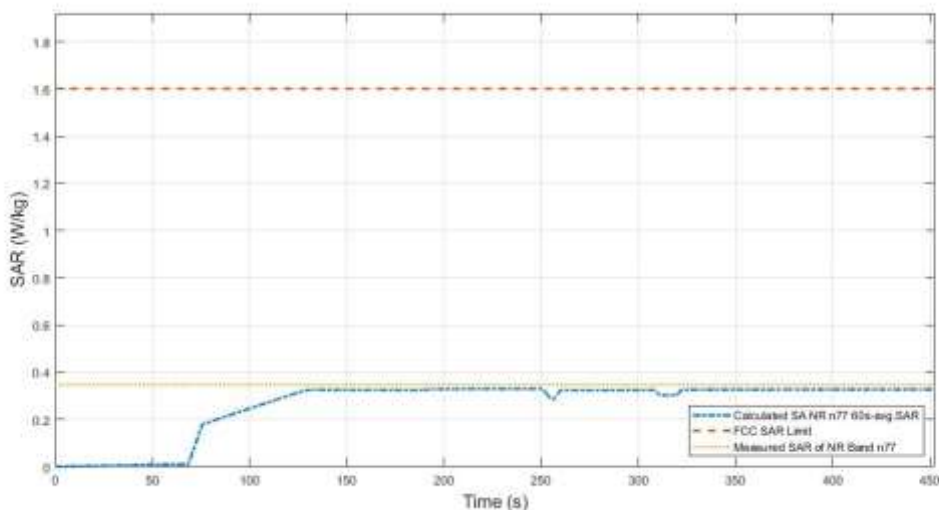


Figure 8.3-4 Total time-averaged SAR in TC02

FCC 1gSAR limit	1.6 W/kg
Max 60s-time average 1gSAR (blue curve)	0.329 W/kg
Device uncertainty	1 dB

TC03: Time_Varying_Tx_Power_Case_1 [WCDMA B2]

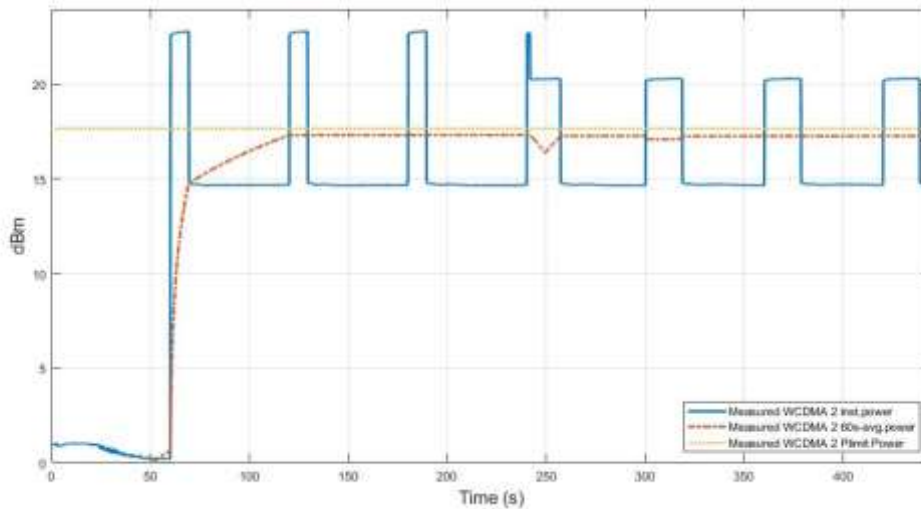


Figure 8.3-5 Time-average conducted power of WCDMA B2 in TC03

In this test, measured 1g SAR would be 0.761 W/kg at 18.0 dBm. Figure 8.3-5 shows the instantaneous and time-averaged Tx power with test sequence A for WCDMA B2 with Plimit 18.0 dBm. In addition, Figure 8.3-5 shows that the moving-average Tx power is around the targeted Plimit value but it is acceptable result due to uncertainty. Also Figure 8.3-6 shows the calculated time-averaged 1gSAR for this test demonstrating that exposure is well below the FCC limit of 1.6W/kg.

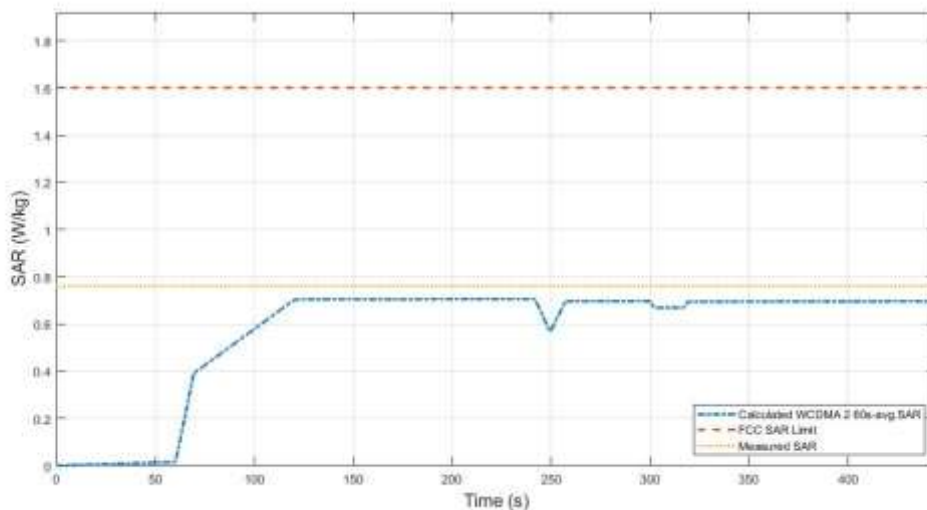


Figure 8.3-6 Total time-averaged SAR in TC03

FCC 1gSAR limit	1.6 W/kg
Max 60s-time average 1gSAR (blue curve)	0.705 W/kg
Device uncertainty	1 dB

TC04: Time_Varying_Tx_Power_Case_1 [GSM1900]

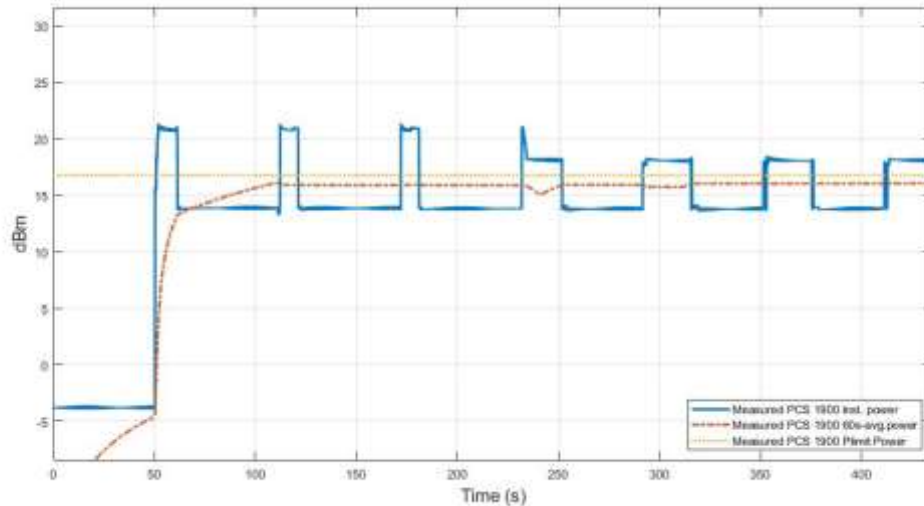


Figure 8.3-7 Time-average conducted power of GSM1900 in TC04

In this test, measured 1g SAR would be 0.530 W/kg at 20.0 dBm. Figure 8.3-7 shows the instantaneous and time-averaged Tx power with test sequence A for GSM1900 with Plimit 20.0 dBm. In addition, Figure 8.3-7 shows that the moving-average Tx power is around the targeted Plimit value but it is acceptable result due to uncertainty. Also Figure 8.3-8 shows the calculated time-averaged 1gSAR for this test demonstrating that exposure is well below the FCC limit of 1.6W/kg.

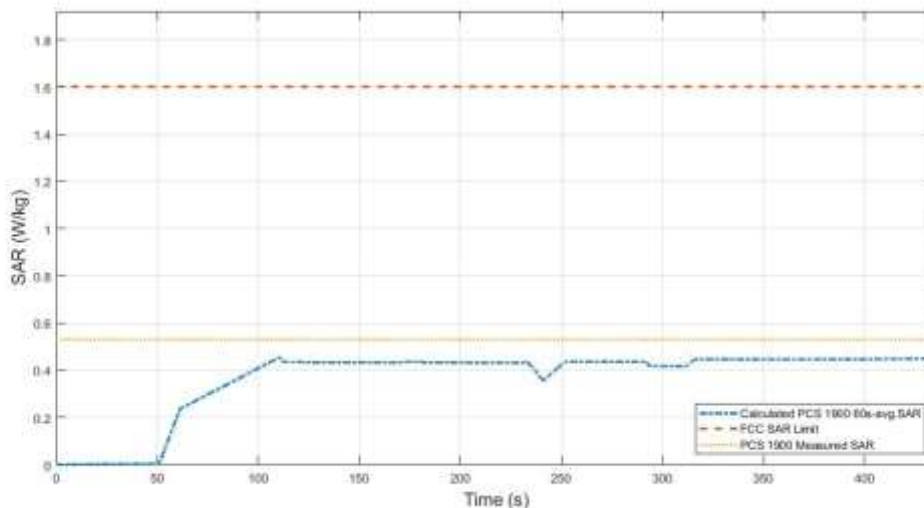


Figure 8.3-8 Total time-averaged SAR in TC04

FCC 1gSAR limit	1.6 W/kg
Max 60s-time average 1gSAR (blue curve)	0.454 W/kg
Device uncertainty	1 dB

TC05: Time_Varying_Tx_Power_Case_2 [LTE B25]

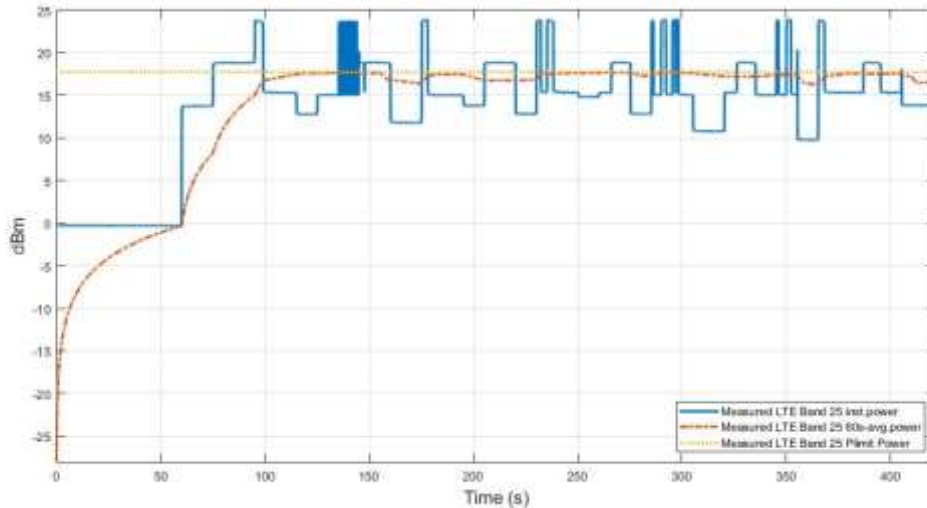


Figure 8.3-9 Conducted Tx power of LTE B25 in TC05

In this test, measured 1g SAR would be 0.796 W/kg at 18.5 dBm. Figure 8.3-9 shows the instantaneous and time-averaged Tx power with test sequence B for LTE B25 with Plimit 18.5 dBm. In addition, Figure 8.3-9 shows that the moving-average Tx power is around the targeted Plimit value but it is acceptable result due to uncertainty. Also Figure 8.3-10 shows the calculated time-averaged 1gSAR for this test demonstrating that exposure is well below the FCC limit of 1.6W/kg.

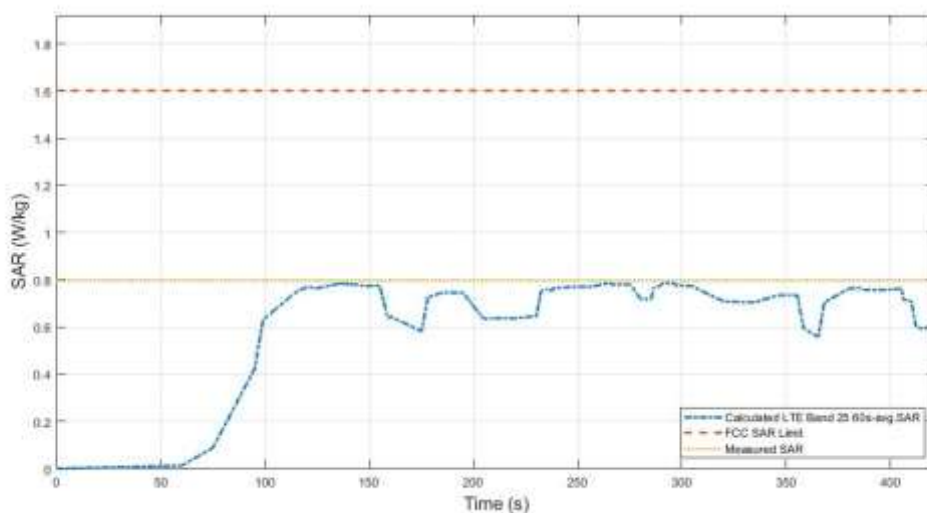


Figure 8.3-10 Total time-averaged SAR in TC05

FCC 1gSAR limit	1.6 W/kg
Max 60s-time average 1gSAR (blue curve)	0.562 W/kg
Device uncertainty	1 dB

TC06: Time_Varying_Tx_Power_Case_2 [NR n77]

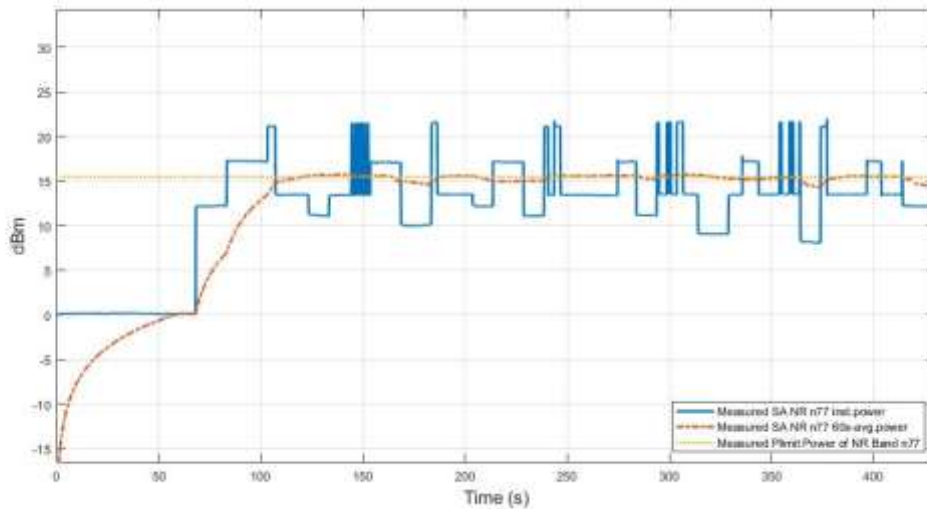


Figure 8.3-11 Conducted Tx power of NR n77 in TC06

In this test, measured 1g SAR would be 0.347 W/kg at 16.0 dBm. Figure 8.3-11 shows the instantaneous and time-averaged Tx power with test sequence B for NR n77 with Plimit 16.0 dBm. In addition, Figure 8.3-11 shows that the moving-average Tx power is around the targeted Plimit value but it is acceptable result due to uncertainty. Also Figure 8.3-12 shows the calculated time-averaged 1gSAR for this test demonstrating that exposure is well below the FCC limit of 1.6W/kg.

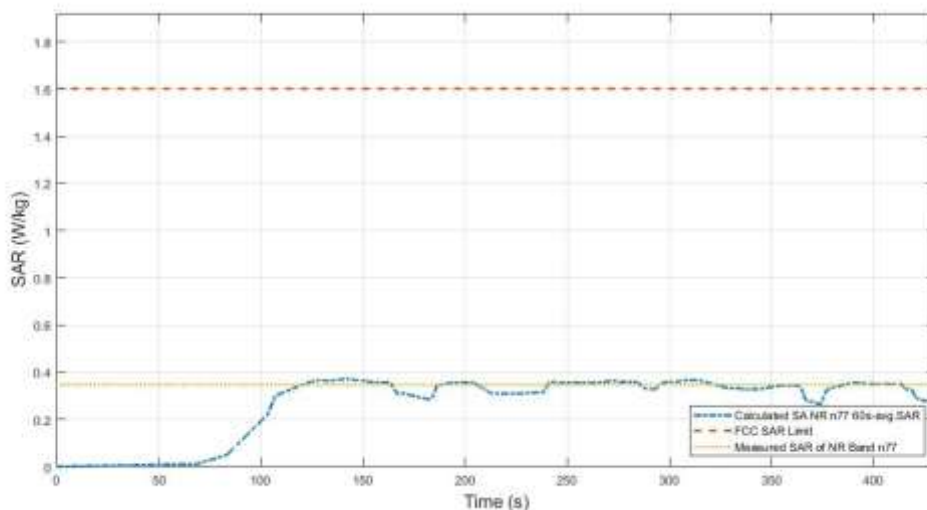


Figure 8.3-12 Total time-averaged SAR in TC06

FCC 1gSAR limit	1.6 W/kg
Max 60s-time average 1gSAR (blue curve)	0.372 W/kg
Device uncertainty	1 dB

TC07: Time_Varying_Tx_Power_Case_2 [WCDMA B2]

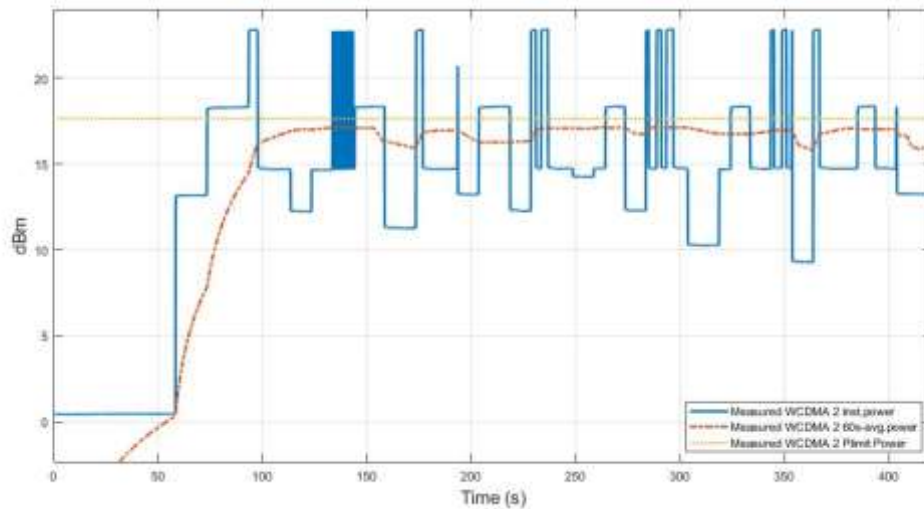


Figure 8.3-13 Conducted Tx power for WCDMA B2 in TC07

In this test, measured 1g SAR would be 0.761 W/kg at 18.0 dBm. Figure 8.3-13 shows the instantaneous and time-averaged Tx power with test sequence B for WCDMA B2 with Plimit 18.0 dBm. In addition, Figure 8.3-13 shows that the moving-average Tx power is around the targeted Plimit value but it is acceptable result due to uncertainty. Also Figure 8.3-14 shows the calculated time-averaged 1gSAR for this test demonstrating that exposure is well below the FCC limit of 1.6W/kg.

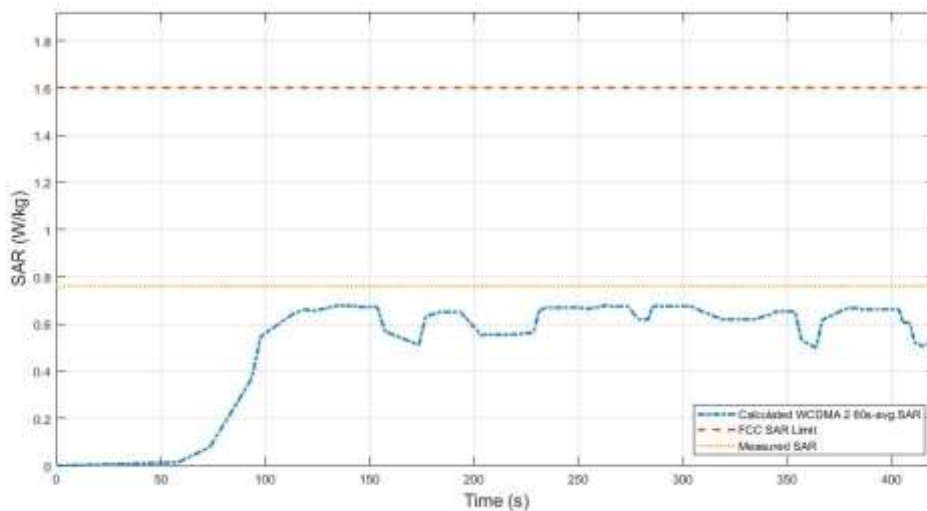


Figure 8.3-14 Total time-averaged SAR in TC07

FCC 1gSAR limit	1.6 W/kg
Max 60s-time average 1gSAR (blue curve)	0.681 W/kg
Device uncertainty	1 dB

TC08: Time_Varying_Tx_Power_Case_2 [GSM1900]

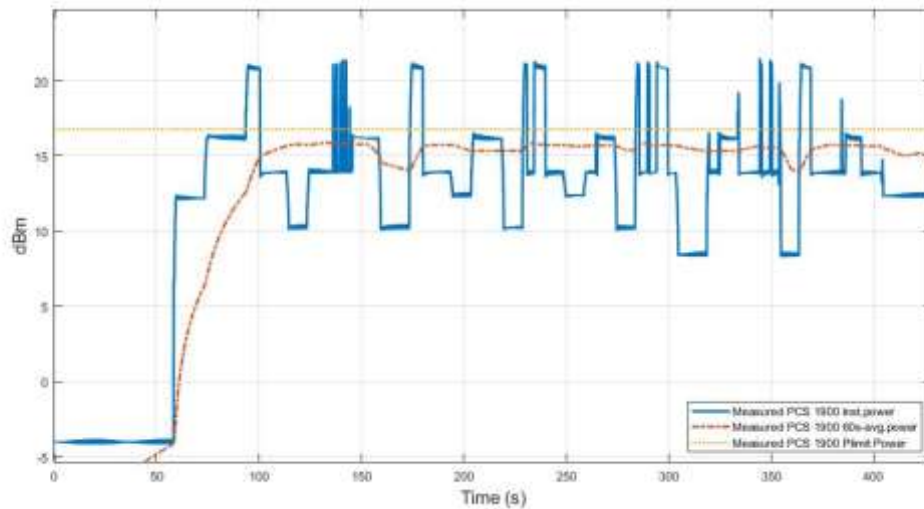


Figure 8.3-15 Conducted Tx power for GSM1900 in TC08

In this test, measured 1g SAR would be 0.530 W/kg at 20.0 dBm. Figure 8.3-15 shows the instantaneous and time-averaged Tx power with test sequence B for GSM1900 with Plimit 20.0 dBm. In addition, Figure 8.3-15 shows that the moving-average Tx power is around the targeted Plimit value but it is acceptable result due to uncertainty. Also Figure 8.3-16 shows the calculated time-averaged 1gSAR for this test demonstrating that exposure is well below the FCC limit of 1.6W/kg.

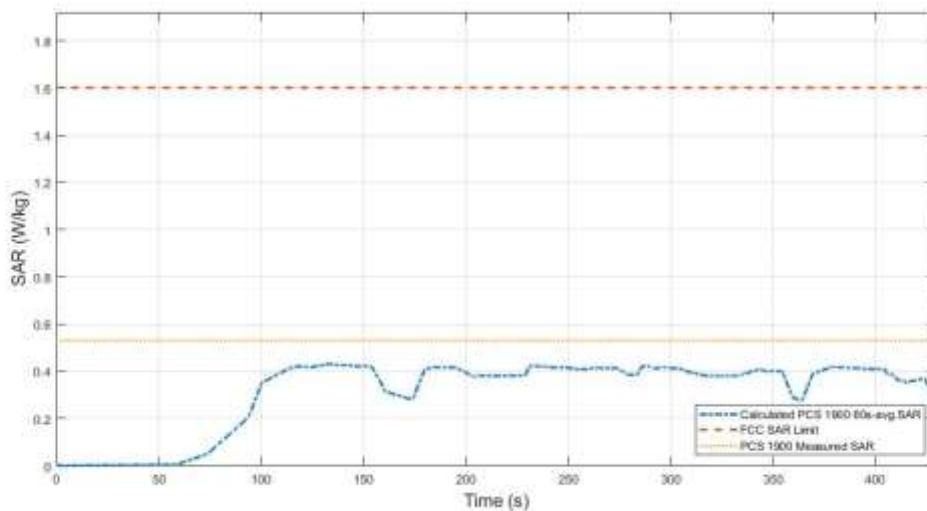


Figure 8.3-16 Total time-averaged SAR in TC08

FCC 1gSAR limit	1.6 W/kg
Max 60s-time average 1gSAR (blue curve)	0.431 W/kg
Device uncertainty	1 dB

8.4 Change in call test results

The test results in this section are obtained following the procedure in Section 5.3.2. The test case corresponds to TC#9 in Table 8.2.1.

TC09: LTE_Call_Disconnect_Reestablishment

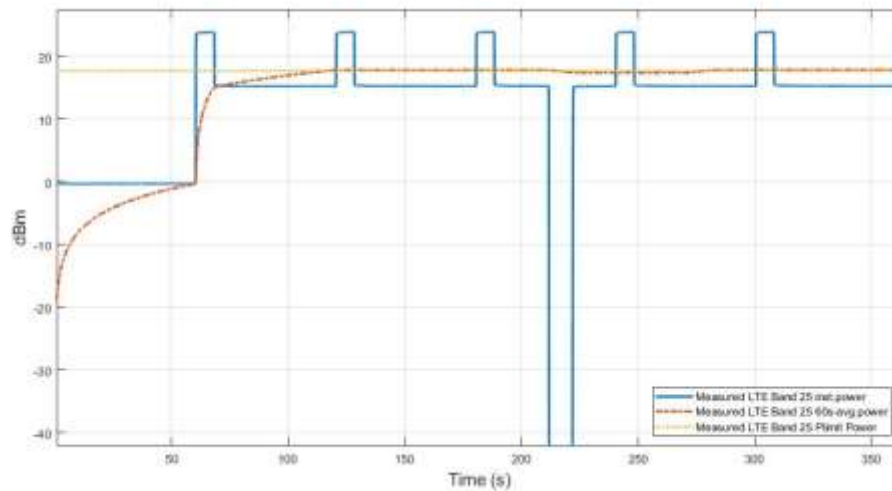


Figure 8.4-1 Conducted Tx power in Call_Disconnect_Reestablishment LTE Band 25 case TC09

In this test, measured 1g SAR would be 0.796 W/kg at 18.5 dBm. Figure 8.4-1 shows the instantaneous and time-averaged Tx power for this test. The call disconnected around 220s and resumed after 10s. It is confirmed for time-average Tx power that the FCC limit was not exceeded, and observed averaging power is around power limit with an uncertainty. Figure 8.4-2 shows the calculated time-averaged 1gSAR for this test demonstrating that exposure is well below the FCC limit of 1.6W/kg. Looking at the results, it can be seen that even if transmission is stopped due to a call drop, the SAR value measured for a period of time window is stored in the window section and is continuously checked.

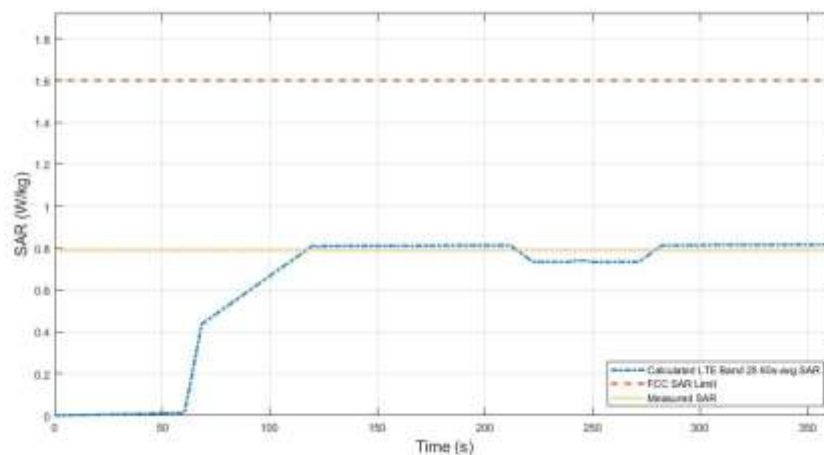


Figure 8.4-2 Total time-averaged SAR in TC09

FCC 1gSAR limit	1.6 W/kg
Max 60s-time average 1gSAR (blue curve)	0.814 W/kg
Device uncertainty	1 dB

8.5 Modulation Change test result

The test results in this section are obtained following the procedure in Section 5.3.8. The test cases correspond to TC#10 in Table 8.2.1.

TC10: LTE_Modulation_Change

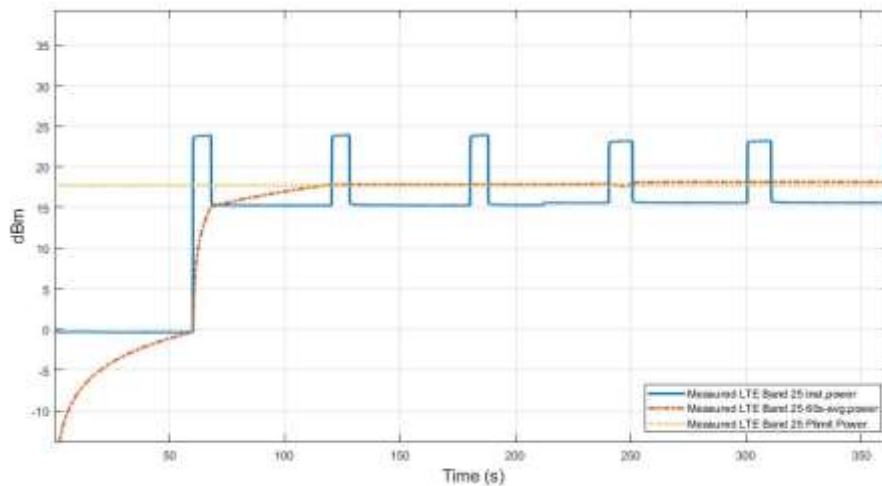


Figure 8.5-1 Conducted Tx power for SAR Modulation Change in test TC10 [LTE Band 25]

In this test, measured 1g SAR would be 0.796 W/kg at 18.5 dBm. Figure 8.5-1 shows the instantaneous and time-averaged Tx power with P_{limit} 18.5 dBm. The nominal maximum power is set at 24 dBm and a switch of modulation is happening from QPSK to 16QAM at 210s where an increase in the MPR value from 0dB to 1dB happens. The measured power meter reading is 23 dBm at maximum output power.

Figure 8.5-1 shows that the moving-average Tx power is around the targeted P_{limit} value but it is acceptable result due to uncertainty. Also Figure 8.5-2 shows the calculated time-averaged 1gSAR for this test demonstrating that exposure is well below the FCC limit of 1.6W/kg.

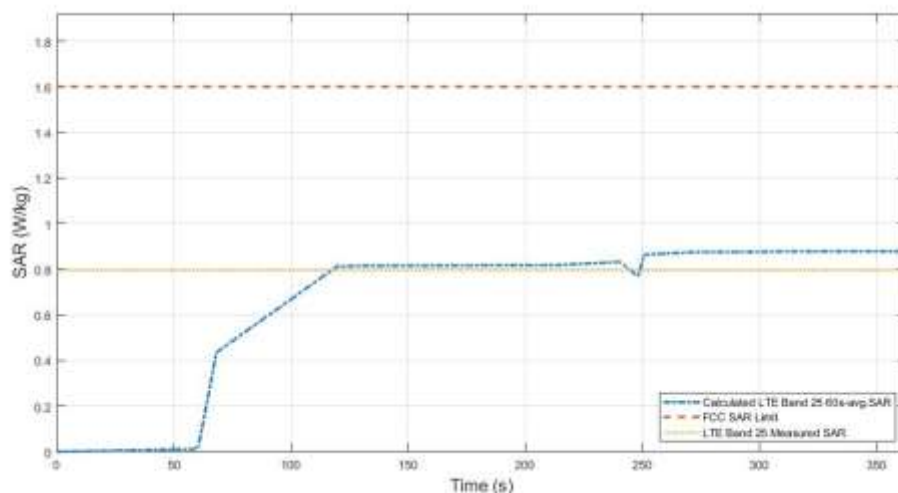


Figure 8.5-2 Total time-averaged SAR in TC10

FCC 1gSAR limit	1.6 W/kg
Max 60s-time average 1gSAR (Blue curve)	0.879 W/kg
Device uncertainty	1 dB

8.6 Re-selection in call test results

The test results in this section are obtained following the procedure in Section 5.3.3. The test cases correspond to TC#11 in Table 8.2.1.

TC11: FR1 to LTE IRAT Re-selection

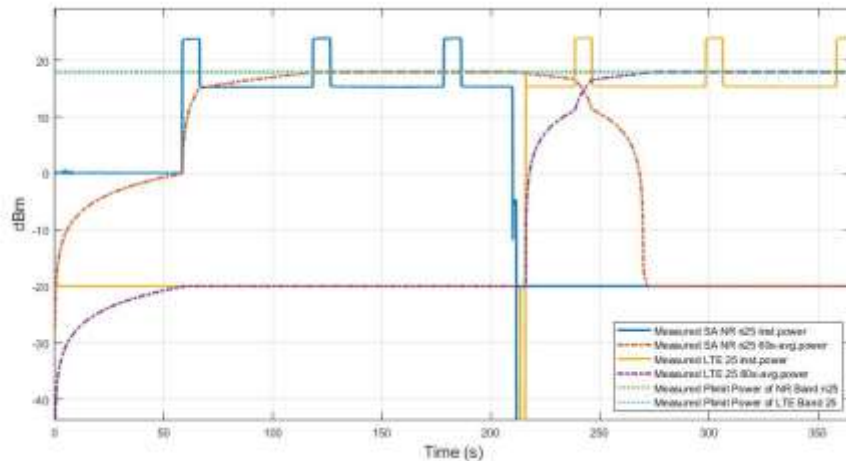


Figure 8.6-1 Conducted Tx power for SAR IRAT re-selection in test TC11 [n25 to LTE B25]

In this test, measured 1g SAR would be 0.728 W/kg at 18.5dBm for NR n25 and 0.796 W/kg at 18.5dBm for LTE B25. Figure 8.6-1 shows the instantaneous and time-averaged conducted Tx power for both LTE Band 25 and NR n25 for the duration of the test. Around time stamp of ~220s, a RAT re-selection from NR n25 to LTE B25 was executed, resulting in reduction of time-averaged power of NR n25 and simultaneous increase in time-averaged power of LTE B25. Here, LTE can use back-off power just after re-selection. Since there is a correlation between n25 and B25, TAS algorithm needs to consider the SAR value used in n25 for B25. Figure 8.6-2 shows the time-averaged 1gSAR value for each of LTE B25 and NR n25, as well as the total SAR value. It can be confirmed that the total 1gSAR is always under the total FCC limit of 1.6W/Kg even in coupling case.

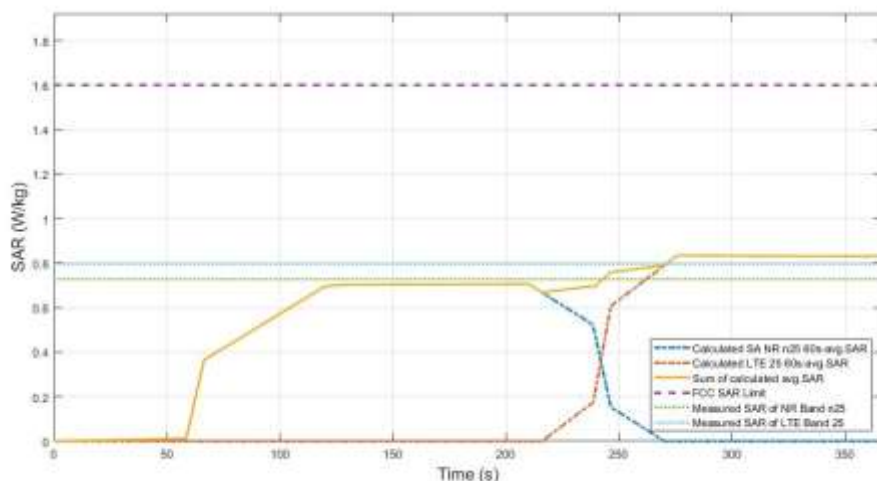


Figure 8.6-2 Conducted Tx power for SAR IRAT re-selection in test TC11

FCC 1gSAR limit	1.6 W/kg
Max 100s-time average 1gSAR (yellow curve)	0.837 W/kg
Device uncertainty	1 dB

8.7 Antenna/Band switching test results

The test results in this section are obtained following the procedure in Section 5.3.3 The test cases correspond to TC#12 in Table 8.2.1.

TC12: LTE_Antenna_Band_Switching

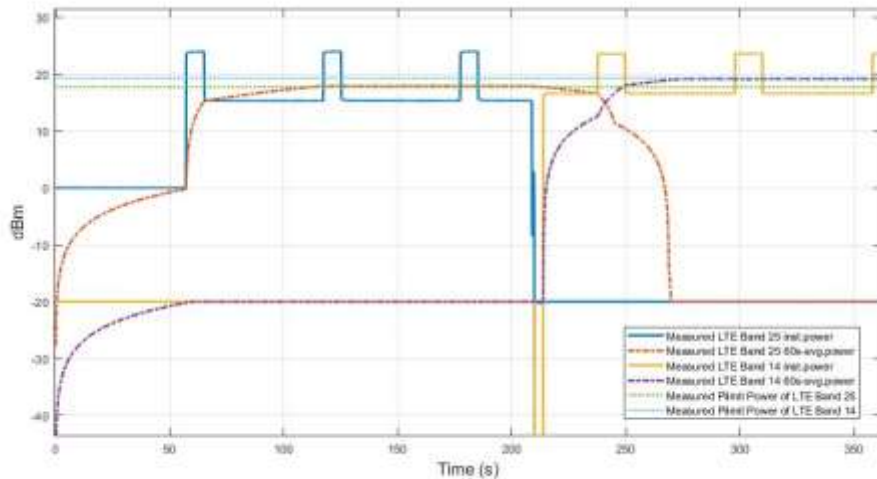


Figure 8.7-1 Conducted Tx power for antenna switching in test TC12 [LTE Band 25 to LTE Band 14]

In this test, measured 1g SAR 0.796 W/kg at 18.5 dBm for LTE B25 and 0.337 W/kg at 20.0 dBm for LTE B14. Figure 8.7-1 shows the instantaneous and time-averaged conducted Tx power for both LTE B25 and LTE B14 for the duration of the test. Around time stamp of ~210s, a band change from LTE B25 to B14 was executed, resulting in reduction of time-averaged power of LTE B25 and simultaneous increase in time-averaged power of LTE B14. Here, LTE can use back-off power just after re-selection. Since there is a correlation between B25 and B14, TAS algorithm needs to consider the SAR value used in B25 for B14. Figure 8.7-2 shows the time-averaged 1gSAR value for each of LTE B25 and LTE B14, as well as the total SAR value. It can be confirmed that the total 1gSAR is always under the total FCC limit of 1.6W/Kg even in coupling case.

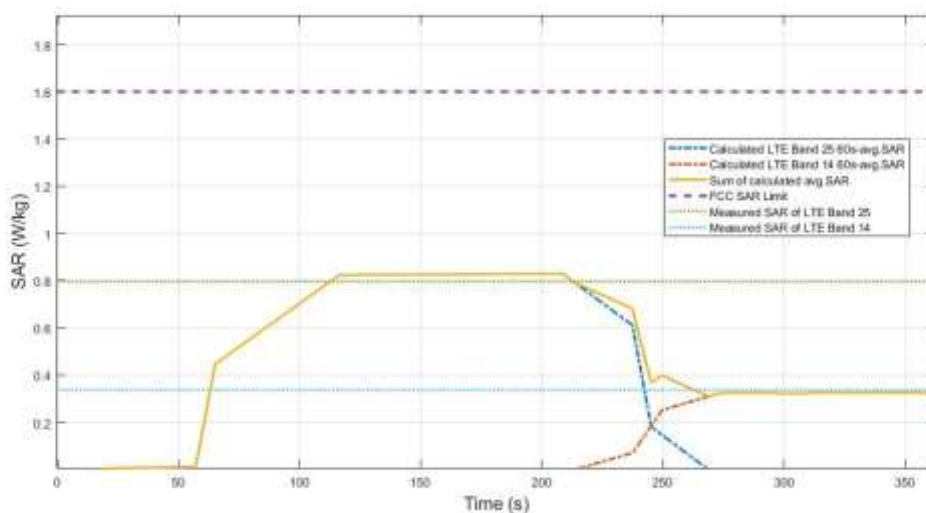


Figure 8.7-2 Total time-averaged SAR in TC12

FCC 1gSAR limit	1.6 W/kg
Max 60s-time average 1gSAR (yellow curve)	0.829 W/kg
Device uncertainty	1 dB

8.8 SAR exposure switching test results

The test results in this section are obtained following the procedure in Section 5.3.5. The test cases correspond to TC#13 in Table 8.2.1.

TC13: NSA_FR1_Dominant_Power_Switching

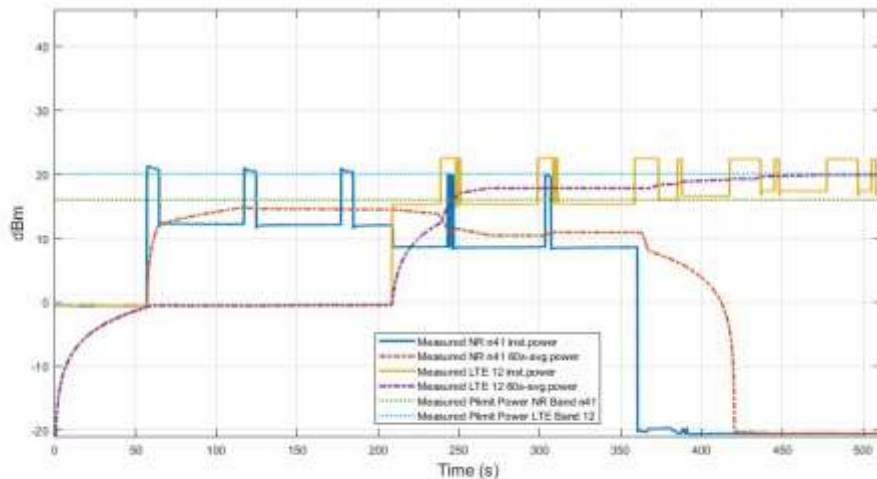


Figure 8.8-1 Conducted Transmitted power for LTE B12 and NR n41 in test TC13

In this test, measured 1g SAR would be 0.206 W/kg at 22.0dBm for LTE B12 and 0.430 W/kg at 16.0dBm for NR n41. The setting value and measured values are described in Table 8.2-1. Figure 8.8-1 shows the instantaneous and time-averaged Tx power for both LTE B12 and NR n41 versus time. When both LTE and FR1 operate in around 200s, averaged Tx power for NR is decreased and averaged Tx power of LTE is increased by taking the SAR budget. After 200s, NR doesn't use transmitted power and LTE takes the all SAR budget.

As shown in Figure 8.8-2, total average SAR is less than 1W/Kg which is below the FCC limit of 1.6W/Kg.

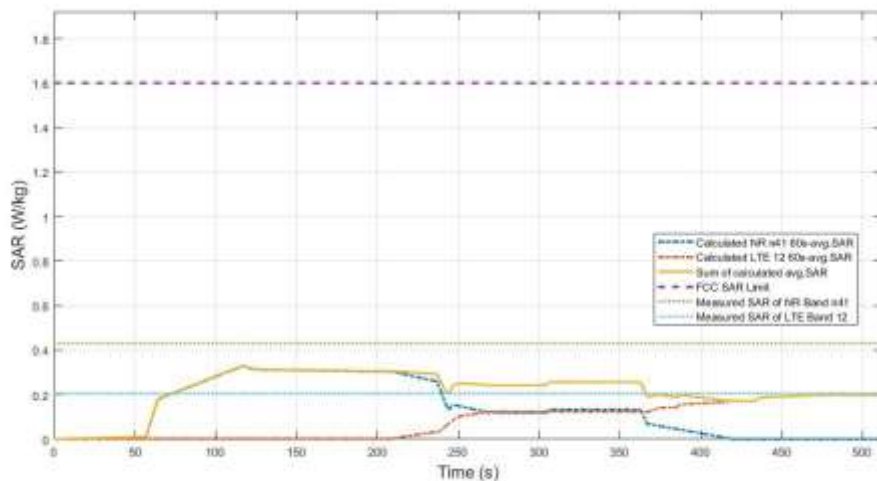


Figure 8.8-2 Total time-averaged SAR FR1 n41 and LTE B12 in TC13

FCC 1gSAR limit	1.6 W/kg
Max 60s-time average 1gSAR (yellow curve)	0.331 W/kg
Device uncertainty	1 dB

8.9 Change in RSI

The test results in this section are obtained following the procedure in Section 5.3.4. The test cases correspond to TC#14 in Table 8.2.1.

TC14: SA_FR1_RF_SAR_Index_Change

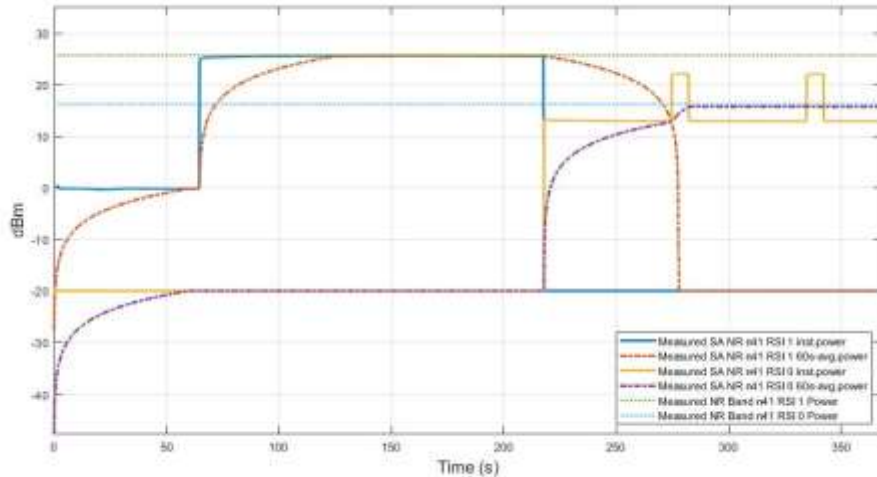


Figure 8.9-1 Conducted Tx power for SAR RSI change in test TC14 [NR Band n41]

In this test, measured 1g SAR would be 0.271W/kg at 26.0dBm (RSI 1) and 0.430 W/kg at 16.0 dBm (RSI 0). Figure 8.9-1 shows the instantaneous and time-averaged conducted Tx power for both NR n41 for the duration of the test. Around time stamp of ~220s, the RSI value is changed from High RSI with Plimit of 26.0 dBm to Low RSI with Plimit of 16.0 dBm, resulting in reduction of target time-averaged power of NR n41. It can be seen that Plimit value of high RSI is lower than that of low RSI, so in high RSI region, more Tx power is limited compared to low RSI region. Figure 8.9-2 shows the time-averaged 1gSAR value for each of low and high RSI value, as well as the total SAR value. We can see that the total 1gSAR is always under the total FCC limit of 1.6W/Kg.

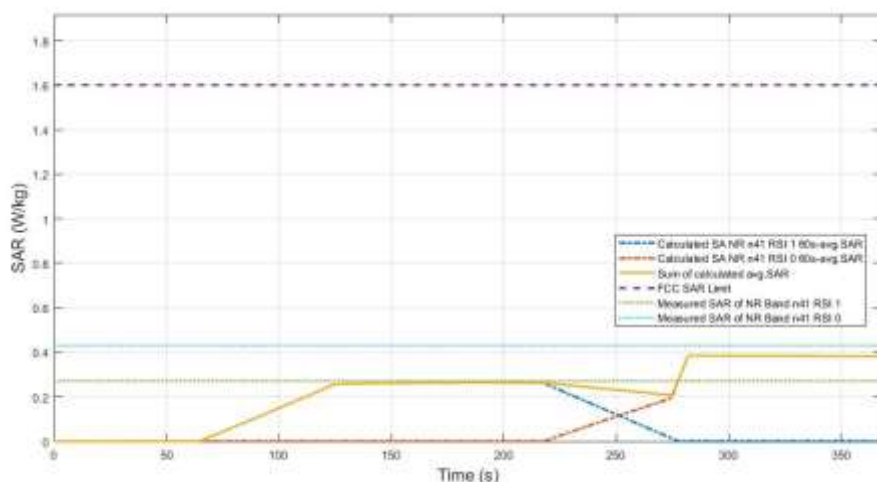


Figure 8.9-2 Total time-averaged SAR in TC14

FCC 1gSAR limit	1.6 W/kg
Sum of calculated average SAR (yellow curve)	0.385 W/kg
Device uncertainty	1 dB

8.10 NSA antenna switching with Spatial TAS

The test results in this section are obtained following the procedure in Section 5.3.6. The test cases correspond to TC#15 in Table 8.2.1.

TC15: NSA_Ant_switching_Spatial_TAS

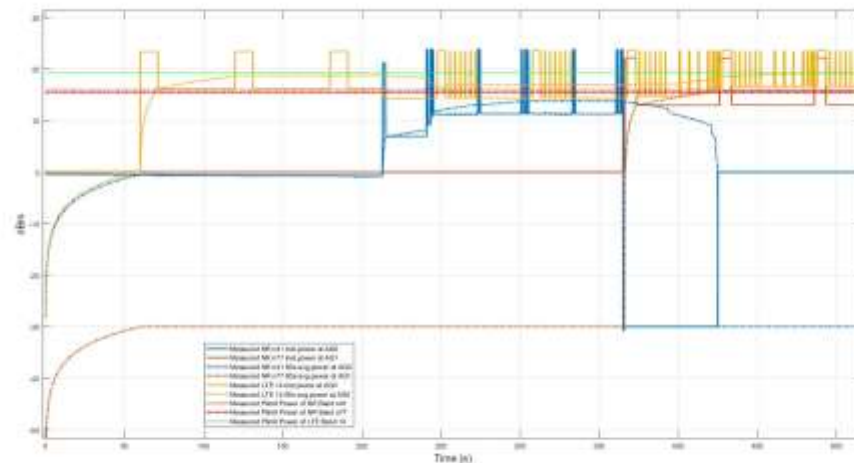


Figure 8.10-1 Conducted Transmitted power for LTE B14(AG0) and NR n41(AG0), n77(AG1) in Test TC15

In this test, measured 1g SAR would be 0.337 W/kg at 20.0dBm for LTE B14, 0.430W/kg at 16.0dBm and 0.347 W/kg at 16.0 dBm for NR n41 and n77. The setting value and measured values are described in Table 8.2-1. Figure 8.10-1 shows the instantaneous and time-averaged Tx power for both LTE B14 and NR Band n41 and NR n77 versus time. When both LTE and NR FR1 operate in around 210s, averaged Tx power for NR is decreased and averaged Tx power of LTE is increased by taking the SAR budget. After 150s, Both NR and LTE use the all SAR budget. As shown in Figure 8.10-2, total average SAR is about 1W/Kg which is below the FCC limit of 1.6W/Kg.

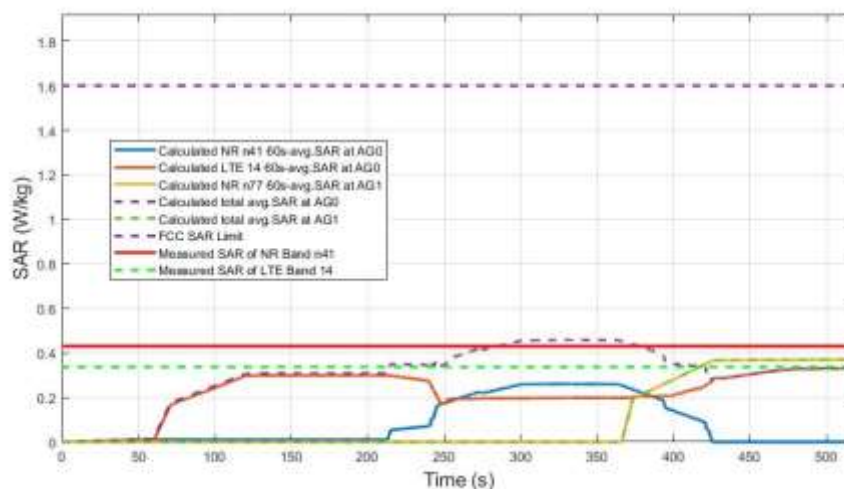


Figure 8.10-2 Total time-averaged SAR in TC16

FCC 1gSAR limit	1.6 W/kg
Sum of calculated average SAR (purple curve)	1.05
Device uncertainty	1 dB

8.11 Intra-band ULCA test results

The test results in this section are obtained following the procedure in Section 5.3.7. The test cases correspond to TC#16 in Table 8.2.1.

TC16: LTE_Intra_Band_UL_CA

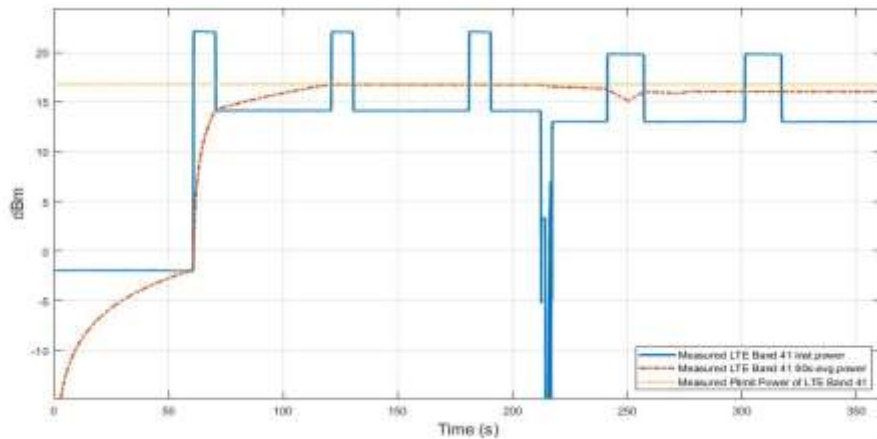


Figure 8.11-1 Conducted Tx power in LTE intra-band ULCA in test TC 16

In this test, measured 1g SAR would be 0.360W/kg at 16.0dBm for LTE B41. Figure 8.11-1 shows the instantaneous and time-averaged conducted Tx power of LTE B41 intra CA for the duration of the test. The setting value and measured values are described in Table 8.11-1. After a 60s from the start a single CC is transmitted. Next after 150s from a single CC transmission, ULCA mode is configured where a new CC is added and the transmission is continued for another 150s. Here, the Back-off power is decreased from Plimit -3dB to more high back-off in coupling case. Because each CC share the same SAR budget. Here, in LTE ULCA mode, there is high priority in PCC. So more power is allocated to PCC and SCC just take the remaining SAR and power. Average power assures the compliance of the average power of the transmitted signal which is below 16.0dBm in a single CC and ULCA mode. Also, the average SAR in Figure 8.11-2 is below the FCC limit of 1.6W/kg.

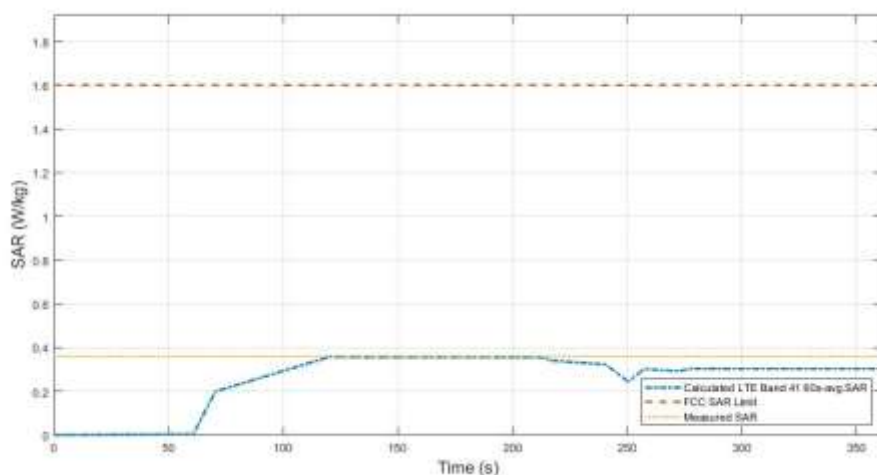


Figure 8.11-2 Total time-averaged SAR in TC16

FCC 1gSAR limit	1.6 W/kg
Sum of calculated average SAR (purple curve)	0.360
Device uncertainty	1 dB

8.12 WLAN/Bluetooth TAS test results

The test results in this section are obtained following the procedure in Section 5.5.1 & 5.5.2 The test cases correspond to TC#17, #18, #19 in Table 8.2.1.

TC17: Tx Power of WLAN TAS (Bluetooth off) [WLAN 2.4G]

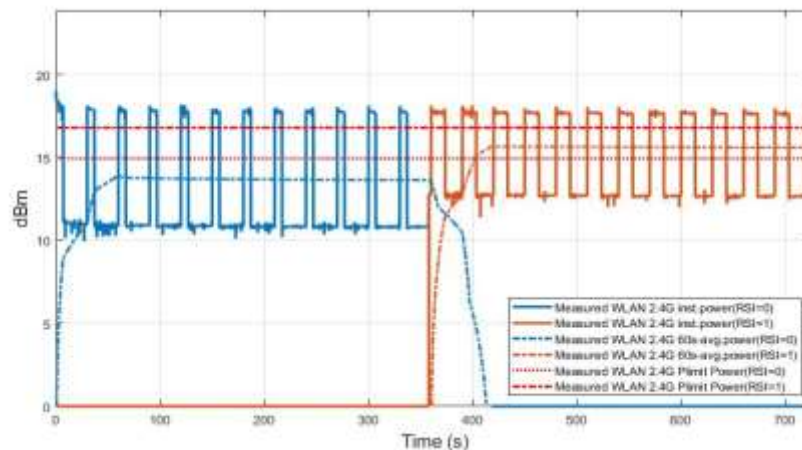


Figure 8.12-1 Conducted Tx power in WLAN 2.4G in test TC 17

In this test, measured 1g SAR would be 0.424W/kg at 14.93dBm for WLAN 2.4G[RSI=0] and 0.408 W/kg at 16.79dBm for WLAN 2.4G[RSI=1]. Figure 8.12-1 shows the instantaneous and time-averaged conducted Tx power for WLAN 2.4G for the duration of the test. In addition, Figure 8.12-1 shows that the moving-average Tx power is around the targeted Plimit value but it is acceptable result due to uncertainty. Also Figure 8.12-2 shows the calculated time-averaged 1g SAR for this test demonstrating that exposure is well below the FCC limit of 1.6W/kg.

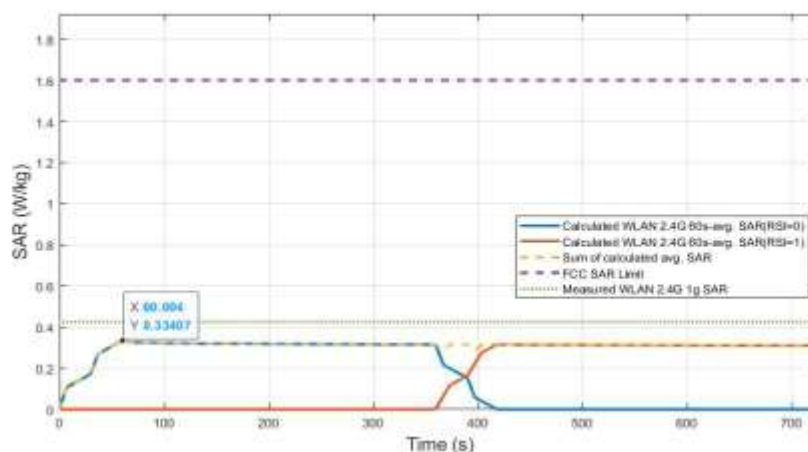


Figure 8.12-2 Total time-averaged SAR in TC17

FCC 1gSAR limit	1.6 W/kg
Sum of calculated average SAR	0.334
Device uncertainty	1 dB

TC18: Tx Power of WLAN TAS (Bluetooth off) [WLAN 5G]

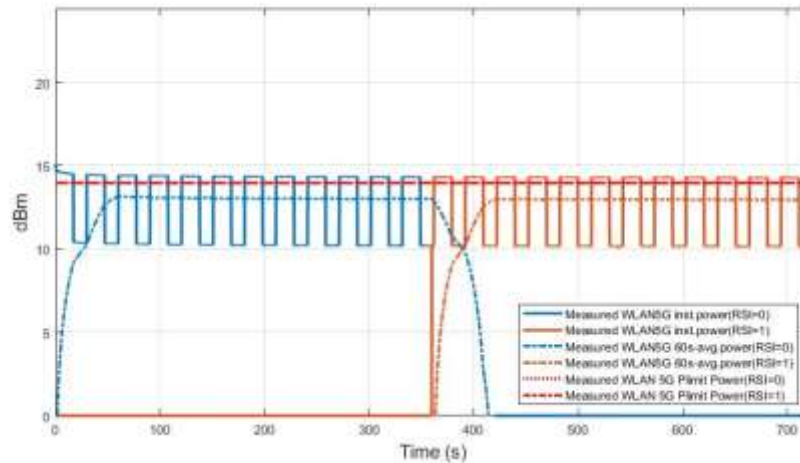


Figure 8.12-3 Conducted Tx power in WLAN 5G in test TC 18

In this test, measured 1g SAR would be 0.252W/kg at 13.96dBm for WLAN 5G[RSI=0] and 0.188 W/kg at 13.96dBm for WLAN 5G[RSI=1]. Figure 8.12-3 shows the instantaneous and time-averaged conducted Tx power for WLAN 5G for the duration of the test. In addition, Figure 8.12-3 shows that the moving-average Tx power is around the targeted Plimit value but it is acceptable result due to uncertainty. Also Figure 8.12-4 shows the calculated time-averaged 1g SAR for this test demonstrating that exposure is well below the FCC limit of 1.6W/kg.

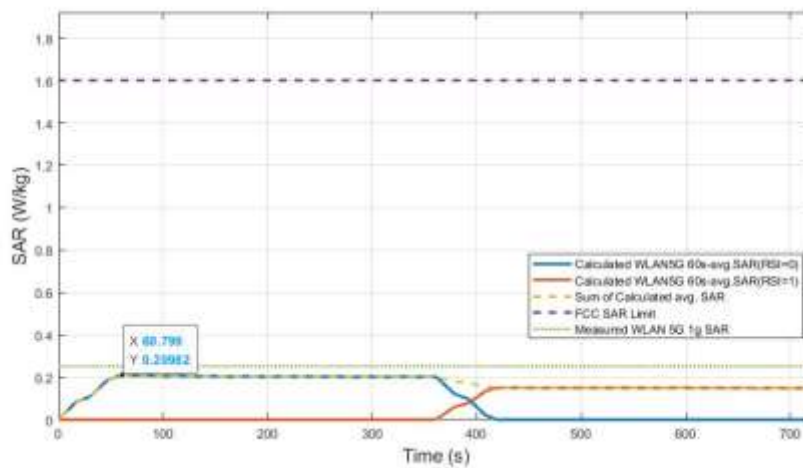


Figure 8.12-4 Total time-averaged SAR in TC18

FCC 1gSAR limit	1.6 W/kg
Sum of calculated average SAR	0.210
Device uncertainty	1 dB

TC19: Tx Power of WLAN TAS (Bluetooth on) [WLAN 5G]

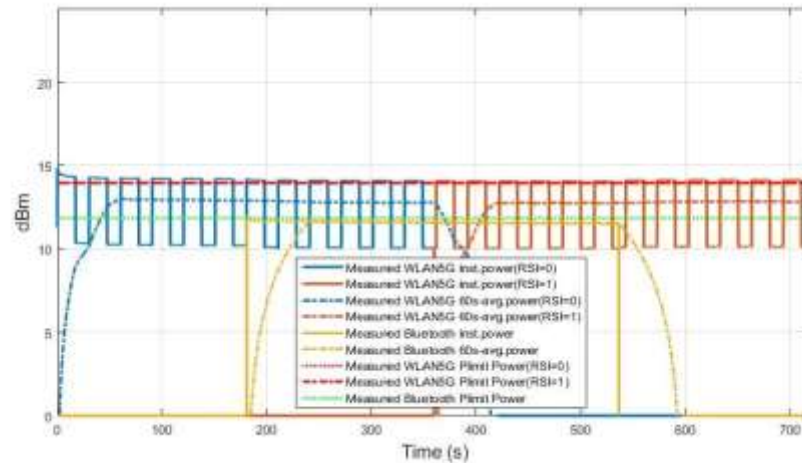


Figure 8.12-5 Conducted Tx power in WLAN 5G/Bluetooth in test TC 19

In this test, measured 1g SAR would be 0.252W/kg at 13.96dBm for WLAN 5G[RSI=0], 0.188 W/kg at 13.96dBm for WLAN 5G[RSI=1] and 0.216 W/kg at 11.85dBm for Bluetooth. Figure 8.12-5 shows the instantaneous and time-averaged conducted Tx power for WLAN 5G and Bluetooth for the duration of the test. In addition, Figure 8.12-5 shows that the moving-average Tx power is around the targeted Plimit value but it is acceptable result due to uncertainty. Also Figure 8.12-6 shows the calculated time-averaged 1g SAR for this test demonstrating that exposure is well below the FCC limit of 1.6W/kg.

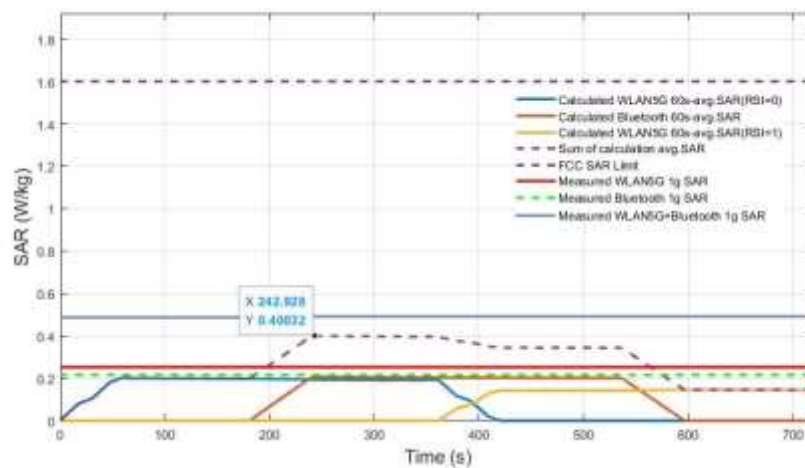


Figure 8.12-6 Total time-averaged SAR in TC19

FCC 1gSAR limit	1.6 W/kg
Sum of calculated average SAR	0.400
Device uncertainty	1 dB

9. Conclusions

Samsung Time-Averaging SAR (TAS) feature employed in Samsung Mobile Phone (FCC ID: A3LSMA266U) has been validated through conducted power measurement as well as SAR measurement. As demonstrated in this report, TAS feature limit the transmit power effectively and shows that SAR value does not exceed 1.6 W/kg for all the transmission scenarios.

10. Equipment List

Manufacturer	Type / Model	S/N	Calib. Date	Calib.Interval	Calib.Due
Narda	Directional Coupler / 4216-10	01490	11/22/2024	Annual	11/22/2025
Narda	Directional Coupler / 4216-10	01489	11/22/2024	Annual	11/22/2025
Narda	Directional Coupler / 4216-10	2090710	06/25/2024	Annual	06/25/2025
Narda	Directional Coupler / 4216-10	01653	06/25/2024	Annual	06/25/2025
RFCOREA	2Way Splitter	473841	12/09/2024	Annual	12/09/2025
Anritsu	Radio Communication Analyzer / MT8821C	6262044720	11/27/2024	Annual	11/27/2025
Anritsu	Radio Communication Analyzer / MT8821C	6262116770	07/29/2024	Annual	07/29/2025
Anritsu	Radio Communication Test Station / MT8000A	6262036812	11/27/2024	Annual	11/27/2025
ROHDE & SCHWARZ	Radio Communication Tester CMW 500	167918	03/20/2024	Annual	03/20/2025
ROHDE & SCHWARZ	Power Sensor / NRP8S	101618	01/12/2024	Annual	01/12/2025
ROHDE & SCHWARZ	Power Sensor / NRP8S	103308	01/12/2024	Annual	01/12/2025
ROHDE & SCHWARZ	Power Sensor / NRP8S	104617	06/25/2024	Annual	06/25/2025
ROHDE & SCHWARZ	Power Sensor / NRP8S	109996	11/12/2024	Annual	11/22/2025
Mini-Circuits	2 Ways DC Pass Power Splitter / ZN2PD2-63-S+	UU95102009	05/28/2024	Annual	05/28/2025

11. References

The following documents contain reference in this technical document.

- [1] [OEM][Samsung+S.LSI_S5400]+Time+average+SAR+algorithm+(FCC)_v1.1
- [2] [OEM] [Samsung S.LSI_S5300] Time-averaged SAR algorithm (FCC)_v.3.3
- [3] [Samsung S.LSI_S5E8835] Time-averaged SAR algorithm for Wi-Fi and BT (Customer)_v.1.0

Appendix A. Test sequence

1.1 Test sequence is generated based on below parameters of the DUT:

1. Measured maximum power (P_{max})
2. Measured Tx power (P_{limit}) to satisfy SAR Compliance
3. Setup time to make SAR Remaining be full
4. Do test according to test sequence

1.2 Test Sequence A waveform:

Based on the parameters above, the test sequence A is generated with one or two levels where one of the levels is maximum power level (P_{max}) which is applied at least for 100s. Based on the second level this test sequence is sub-categorized into four different sequences used

- a. Test Sequence A.i where after P_{max} , a second level of P_{limit} is requested till the end of the test
- b. Test Sequence A.ii where after P_{max} , a second level of $P_{max}-3dB$ is requested till the end of the test
- c. Test Sequence A.iii where after P_{max} , a second level of $P_{limit}-3dB$ is requested till the end of the test
- d. Test Sequence A.iv where only P_{max} is requested till the end of the test

1.3 Test Sequence B waveform:

Based on the parameters above, the Test Type B is generated with pre-defined power levels, which

is described in Table 1.3.1

Table 1.3.1 Table of test sequence B

Time duration (second)	Power level (dB)
15	$P_{limit} - 5$
20	P_{limit}
20	$P_{limit} + 5$
10	$P_{limit} - 6$
20	P_{max}
15	P_{limit}
15	$P_{limit} - 7$
20	P_{max}
10	$P_{limit} - 5$
15	P_{limit}
10	$P_{limit} - 6$
20	$P_{limit} + 5$
10	$P_{limit} - 4$
15	P_{limit}
10	$P_{limit} - 6$
20	P_{max}
15	$P_{limit} - 8$
15	P_{limit}
20	P_{max}
10	$P_{limit} - 9$
20	$P_{limit} + 5$
20	P_{limit}
15	$P_{limit} - 5$

Appendix B. TAS Test setup Photo

Please refer to test setup photo file no as follows

Report NO.
HCT-SR-2501-FC003-P